

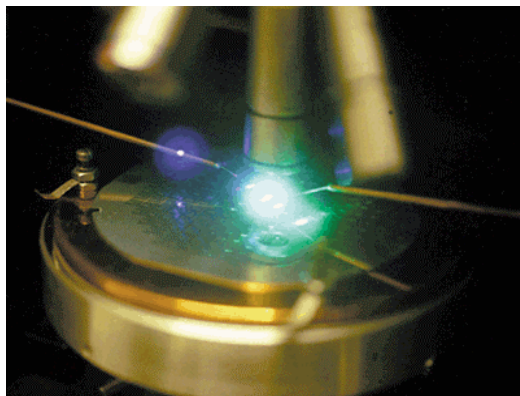


# Nonlinear Spectroscopy of Si Nanocrystals & Step-Edges

Mike Downer  
University of Texas at Austin

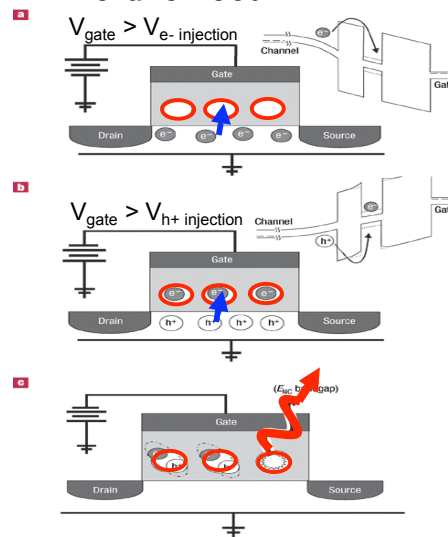
*Si nanostructures have properties & applications different from those of bulk Si*

“Si lasers start to take shape”



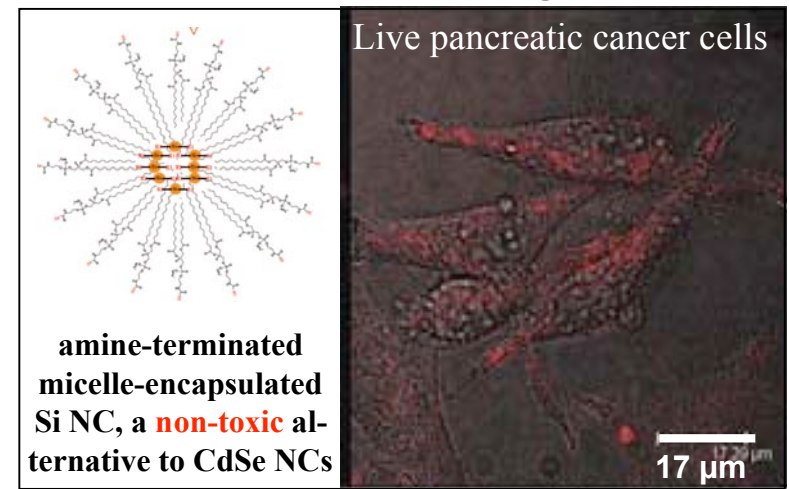
Observation of optical gain in Si nanocrystals embedded in SiO<sub>2</sub>  
Pavesi et al., Nature 408, 440 (2000)

## Field-effect LED



Walters et al, Nature Mat. 4,143 (2005).

## In vivo bio-sensing



Erogbogbo et al, ACS Nano.2, 873 (2008)

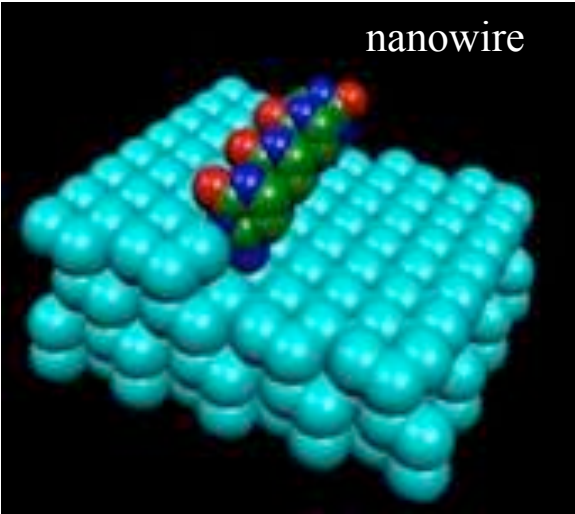
*These interesting properties originate at Si NC/SiO<sub>2</sub> interfaces.  
⇒ SHG has a reputation for being interface-specific*



# Nonlinear Spectroscopy of Si Nanocrystals & Step-Edges

Mike Downer  
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*Si nanostructures have properties & applications different from those of bulk Si*

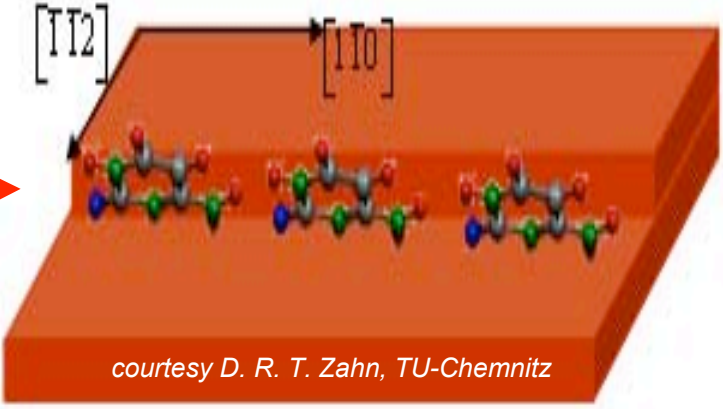


nanowire

*silicon stepped surfaces provide **templates** for*

← *1D quantum wires,<sup>1</sup>*  
*molecular electronics,<sup>2</sup>*  
*atomic-scale memory,<sup>3</sup>*  
*quantum computers<sup>4</sup>*  
*& other nano-electronic structures*

→



courtesy D. R. T. Zahn, TU-Chemnitz

DNA bases adsorbed at vicinal Si  
Mauricio *et al.*, *Nanoletters* **3**, 479 (2003)

<sup>1</sup>McChesney, *Nanotech.* **13**, 545 (02)

<sup>2</sup>Kasemo, *Surf. Sci.* **500**, 656 (02)

<sup>3</sup>Bennewitz, *Nanotech.* **14**, 499 (02)

<sup>4</sup>Ladd, *Phys. Rev. Lett.* **89**, 017901 (02)

*These interesting properties originate at Si NC/SiO<sub>2</sub> interfaces. → **step-edges***  
 ⇒ *SHG has a reputation for being interface-specific*

# Co-workers

## Si NCs



Junwei Wei

## Si step-edges

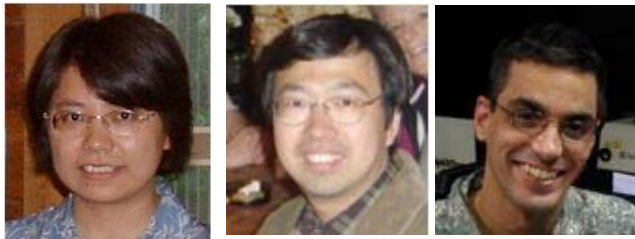


Robert Ehler

## Theory



Bernardo Mendoza  
CIO, León, México



Y. Jiang  
PhD 2002

Liangfeng Sun  
PhD 2006

Pete Figliozzi  
PhD 2007

Adrian Wirth (MS 2007)



Jinhee Kwon  
PhD 2006



Yongqiang An  
PhD UC-Boulder  
2004



W. Luis Mochan  
U. Nacional Autónoma  
Cuernavaca, México

## Financial Support:

- Robert Welch Foundation
- U.S. National Science Foundation

# Their elusive nano-interfaces make Si NCs interesting & challenging

diameter	# atoms	# surface atoms	surface atom fraction
2 nm	209	98	0.47
5 nm	3272	616	0.19

(PL)

## Radiative double bonds:

Wolkin *et al.*, Phys. Rev. Lett. **82**, 197 (1999)  
Luppi & Ossicini, Phys. Rev. B **71** (2005)

## Bridge bonds:

Sa'ar *et al.*, Nano Lett. **5**, 2443 (2005).

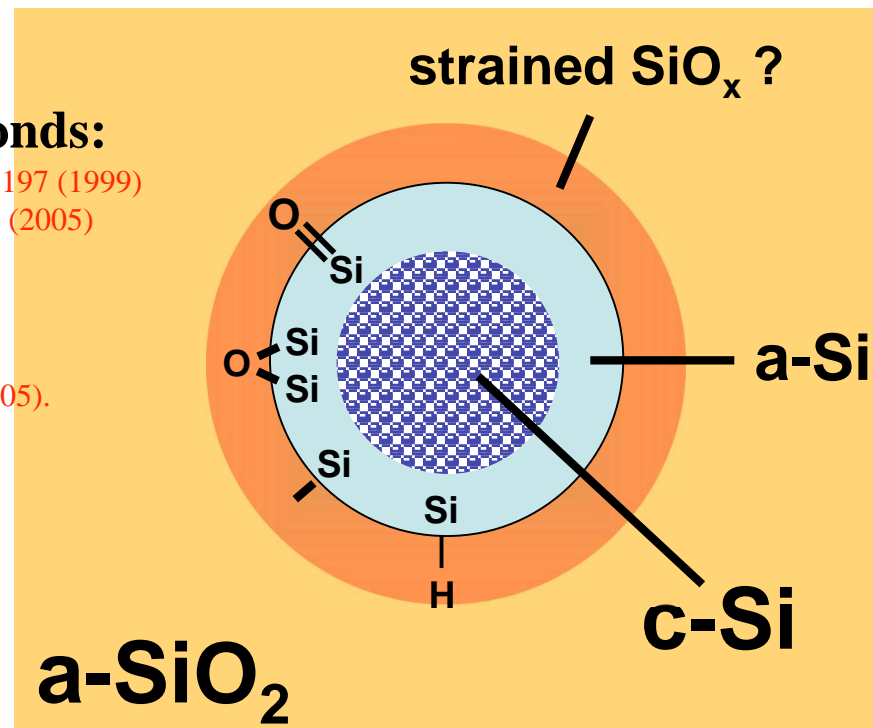
## Dangling bonds

strained  $\text{SiO}_x$  ?

(XPS, Raman)

## Transition layer(s):

Daldosso *et al.*, Phys. Rev. B **68**, (2003)



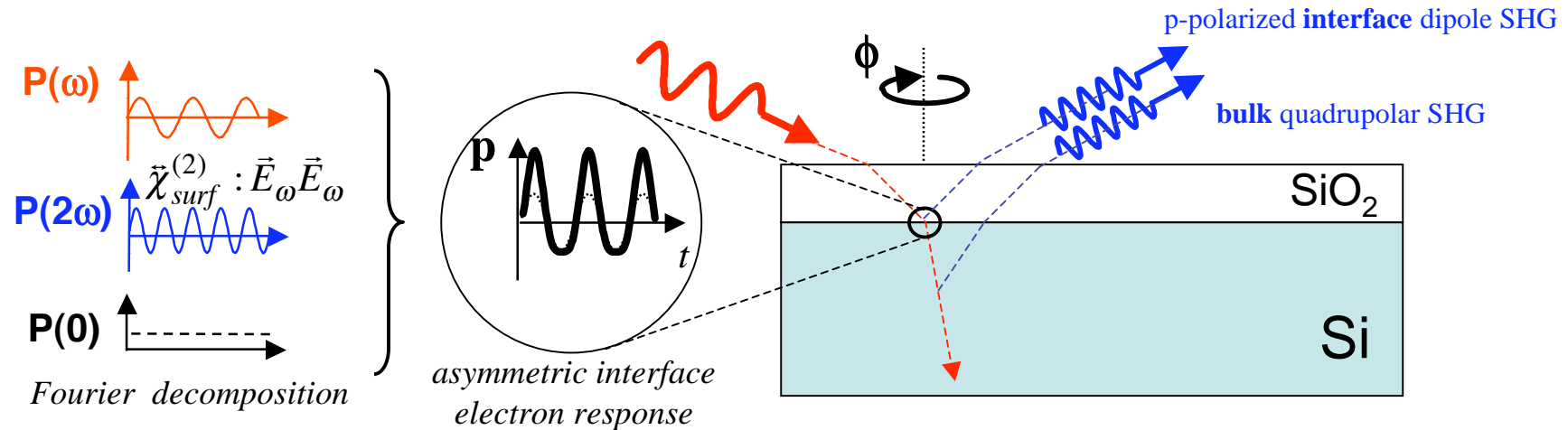
a-Si ? (SHG)

c-Si (SE)

- Buried nano-interfaces inaccessible to many surface science probes and challenging to described theoretically (e.g. by DFT, Monte Carlo)
- Here we use multiple complementary spectroscopies

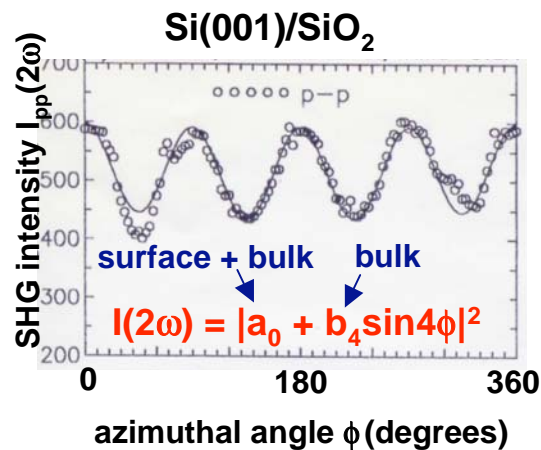
# Surface & bulk contributions to SHG from planar surfaces are never separated with full rigor...

J. E. Sipe *et al.*, Phys. Rev. B **35**, 1129 (1987)

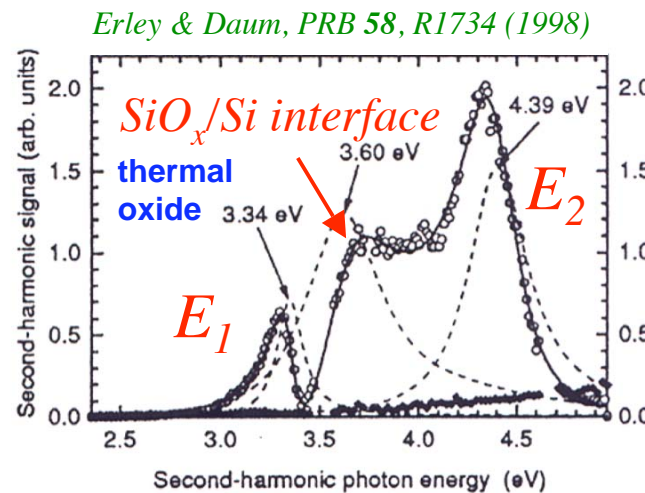


... but empirical separation is usually possible based on:

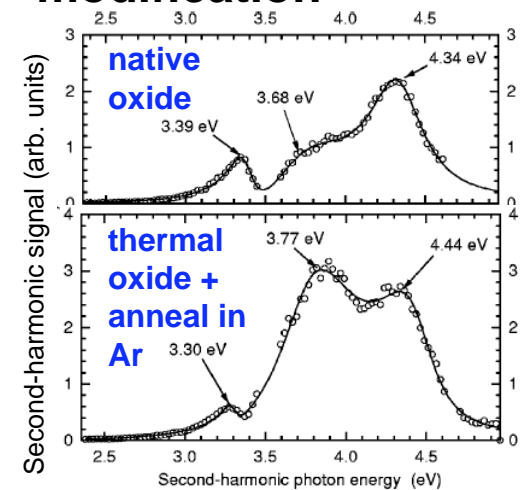
## 1. azimuthal anisotropy



## 2. spectrum



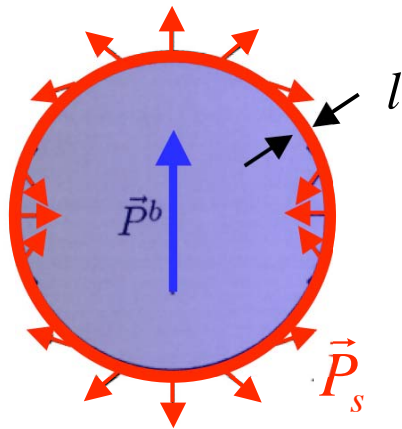
## 3. sensitivity to interface modification



# Similarly, nano-interface & bulk contributions to SHG from Si NCs are intertwined, and must be distinguished empirically

Mochan *et al.*, Phys. Rev. B **68**, 085318 (03)

single nanoparticle:



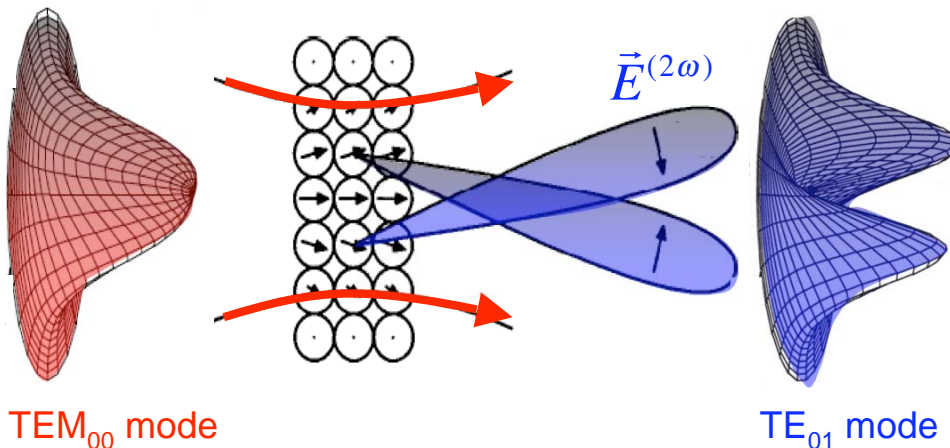
From symmetry alone,

$$\vec{P}^b(\vec{r}) = \gamma \nabla E^2 + \delta' \vec{E} \cdot \nabla \vec{E}$$

$$\vec{P}^s(\vec{r}) = \chi_{ijk}^s(a, b, f) F_j F_k,$$

assuming  $l \ll r_{NC} \ll \lambda$

uniform nano-composite:



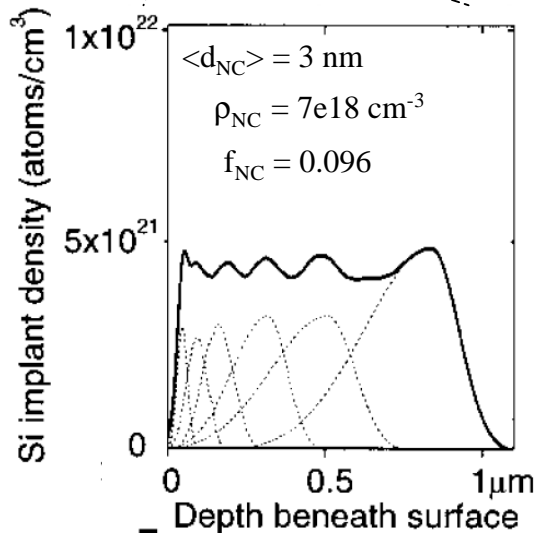
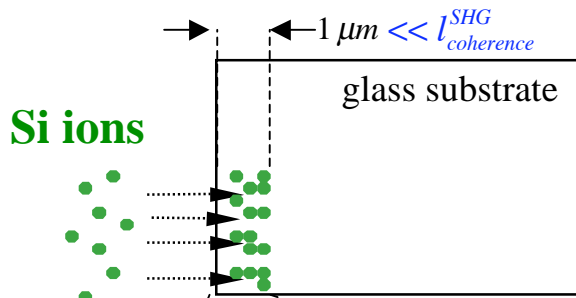
$$\vec{P}^{NL} = \Delta' \vec{E} \cdot \nabla \vec{E}$$

$$\Delta' \equiv n_{NC} [\gamma_e(\delta', \gamma, a, b, f) - \gamma_m(\delta', \gamma, a, b, f) - \gamma_q(a, b, f) / 6]$$

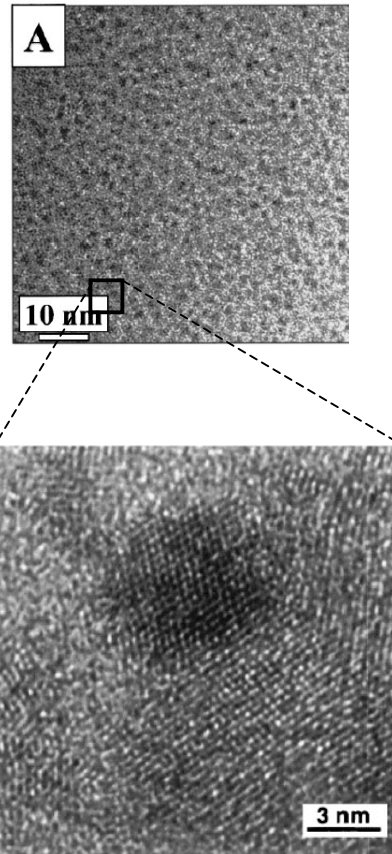
# One group of samples is prepared by Si ion implantation into SiO<sub>2</sub>

C. W. White *et al.*, NIM B **141**, 228 (1998) - ORNL

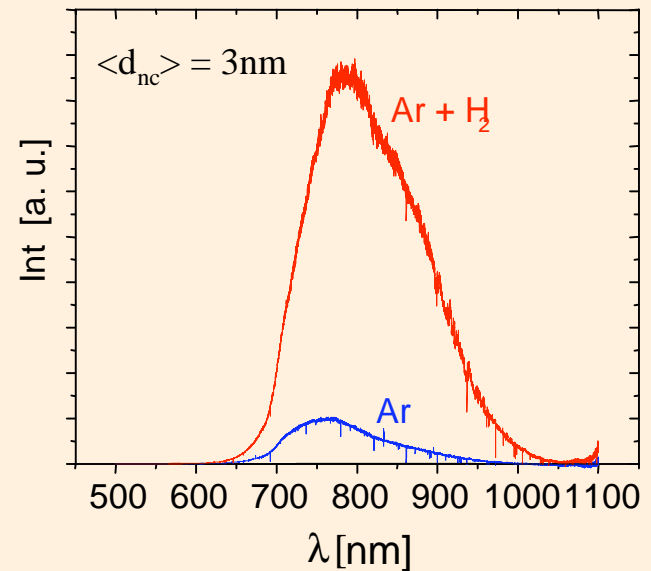
- ① • Multi-energy implant (35-500 keV) yields uniform NC density (simplifies optical analysis)
- ② • Samples annealed @ 1100 C / 1 hr in **Ar or Ar + H<sub>2</sub>** to precipitate NC formation  
 $\langle d_{NC} \rangle = 3, 5, 8 \text{ nm} \pm 50\%$



## TEM Images



## Photoluminescence excitation @ 486 nm



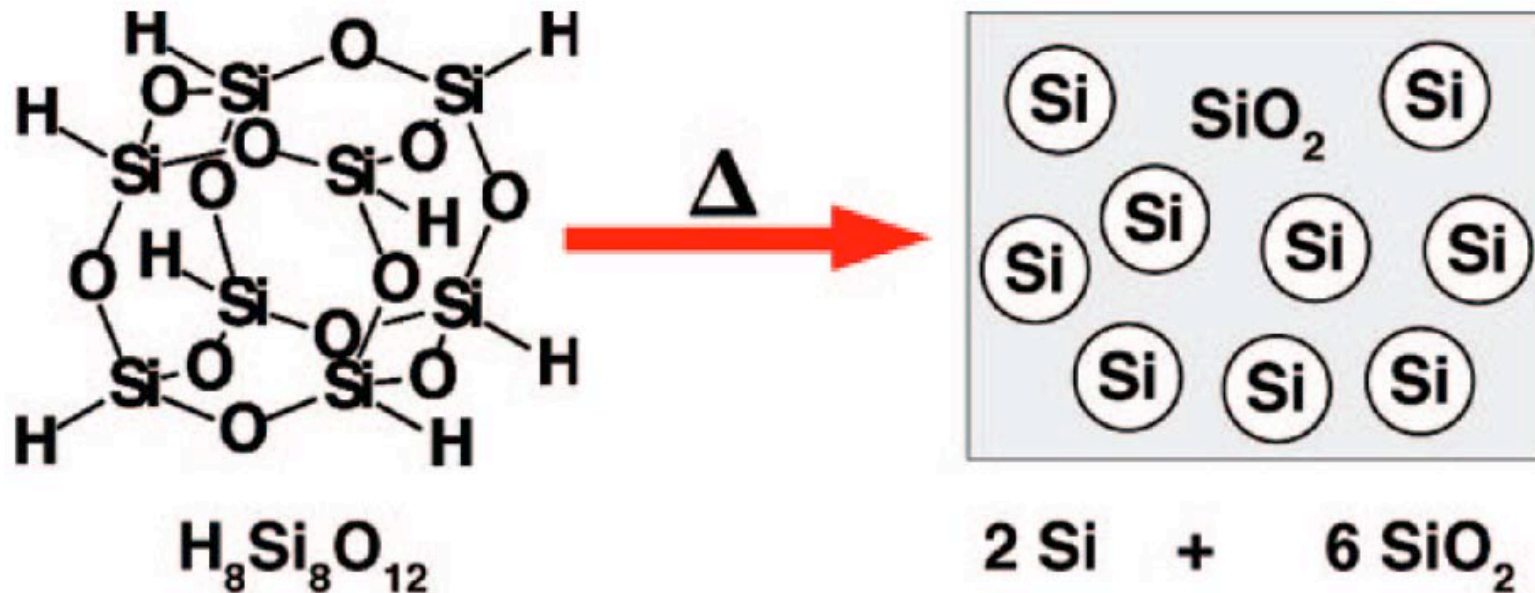
*PL spectrum is unchanged throughout the excitation range 250 < λ < 500 nm*

López *et al.*, Appl. Phys. Lett. **9**, 1637 (2002)

X-ray diffraction confirms crystallinity after annealing

# We also fabricate Si NC samples on a benchtop by thermolysis of hydrogen silsesquioxane (HSQ)

• C. M. Hessel *et al.*, Chem. Mater. **18**, 6139 (2006); J. Phys. Chem. C **111**, 6956 (2007)

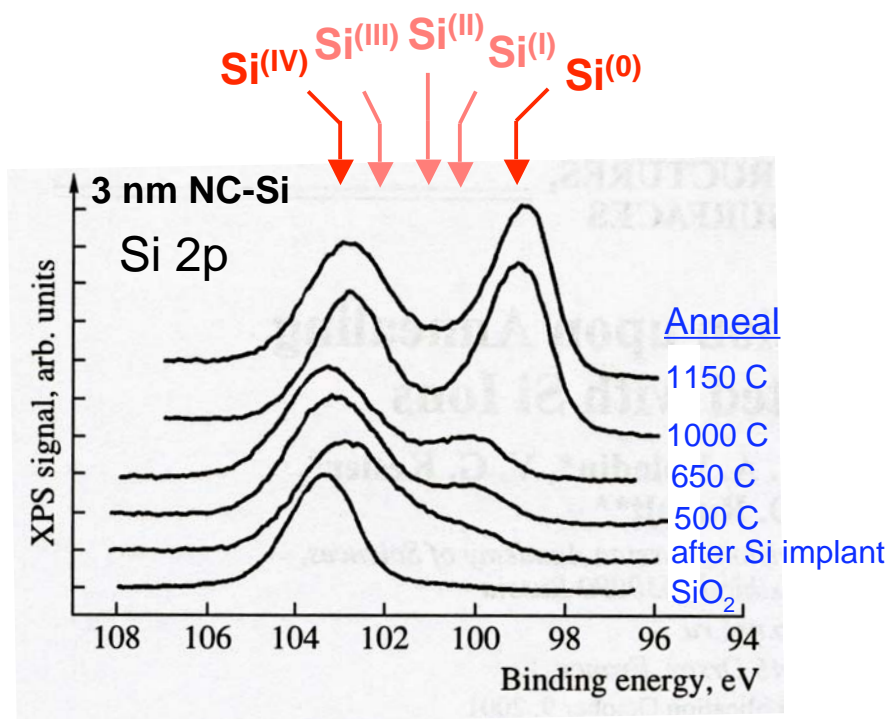




# XPS and Raman scatter document conversion of multiply-coordinated a-Si clusters into 4-fold-coordinated c-Si NCs

Similar measurements by previous investigators {  
 Kachurin *et al.*, *Semiconductors* **36**, 647 (2002)  
 \_\_\_\_\_, *Fiz. Tekh. Poluprov.* **36**, 685 (2002)  
 Hessel, *J. Chem. Phys.* **112**, 14247 (2008)

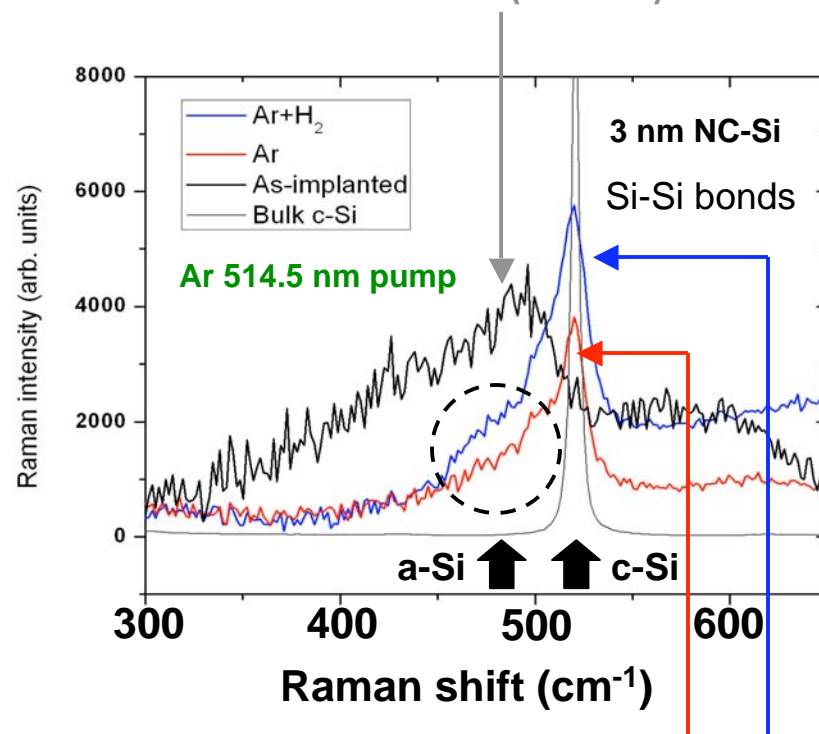
## XPS



After annealing at > 1000 C, negligible sub-oxide is detectable by XPS.

## Raman backscatter

As-implanted layer is dominated by clusters of a-Si (480 cm<sup>-1</sup>)



Annealed layer is dominated by c-Si (520 cm<sup>-1</sup>) ...

... but low energy tail suggests residual a-Si content

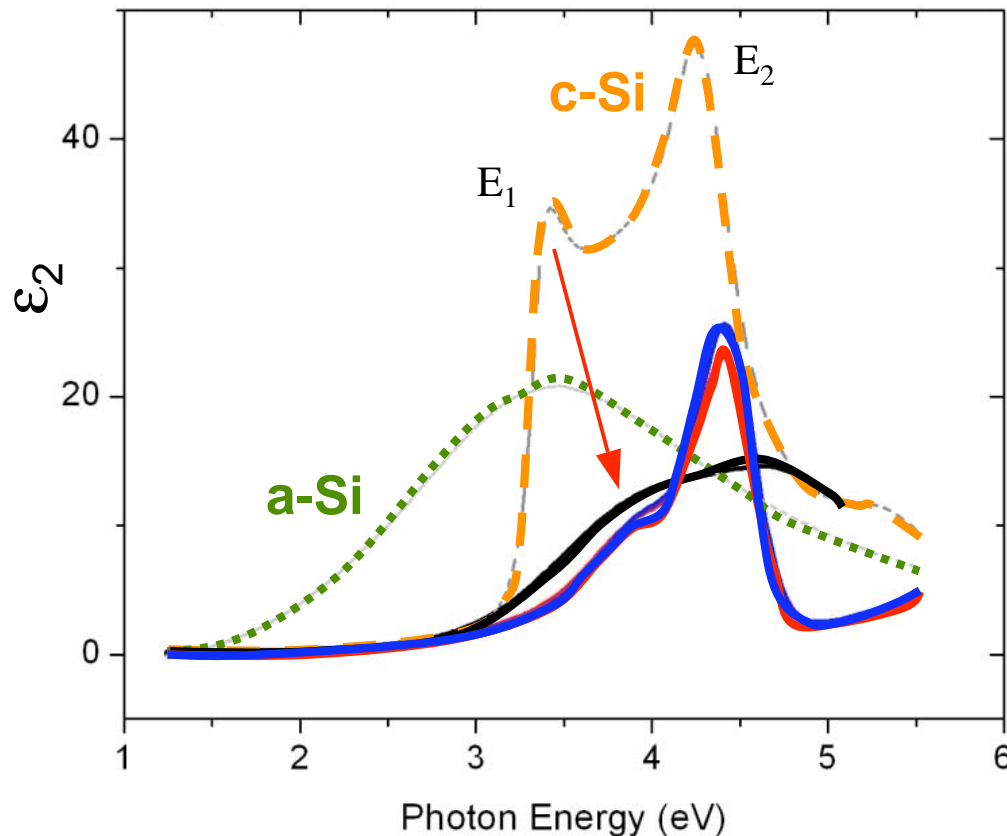
# Spectroscopic ellipsometry (SE) shows modified c-Si $E_1$ and $E_2$ critical points after annealing

[1] En Naciri *et al.* J. Chem. Phys. **129**, 184701 (2008)

[2] Cen *et al.*, Appl. Phys. Lett. **93**, 023122 (2008)

[3] Seino, Bechstedt, Kroll, Nanotech. **20**, 135702 (2009)

} previous related SE results



## as-implanted:

- no  $E_{1,2}$  critical point features
- consistent with small a-Si clusters

## after 1100 C anneal in Ar:

- $E_{1,2}$  peaks appear
- $E_1$  suppressed, blue-shifted
- consistent with:
  - previous SE measurements [1,2]
  - *ab initio* calculations of optical properties of Si NCs in  $\text{SiO}_2$  [3]

## after 1100 C anneal in Ar + $\text{H}_2$ :

- negligible further change

- SE appears selectively sensitive to c-Si core of Si NCs
- Measured  $\epsilon_{1,2}$  determine Fresnel factors used in SHG analysis

# PL excitation spectrum demonstrates that linear absorption occurs primarily in bulk c-Si cores, consistent with SE

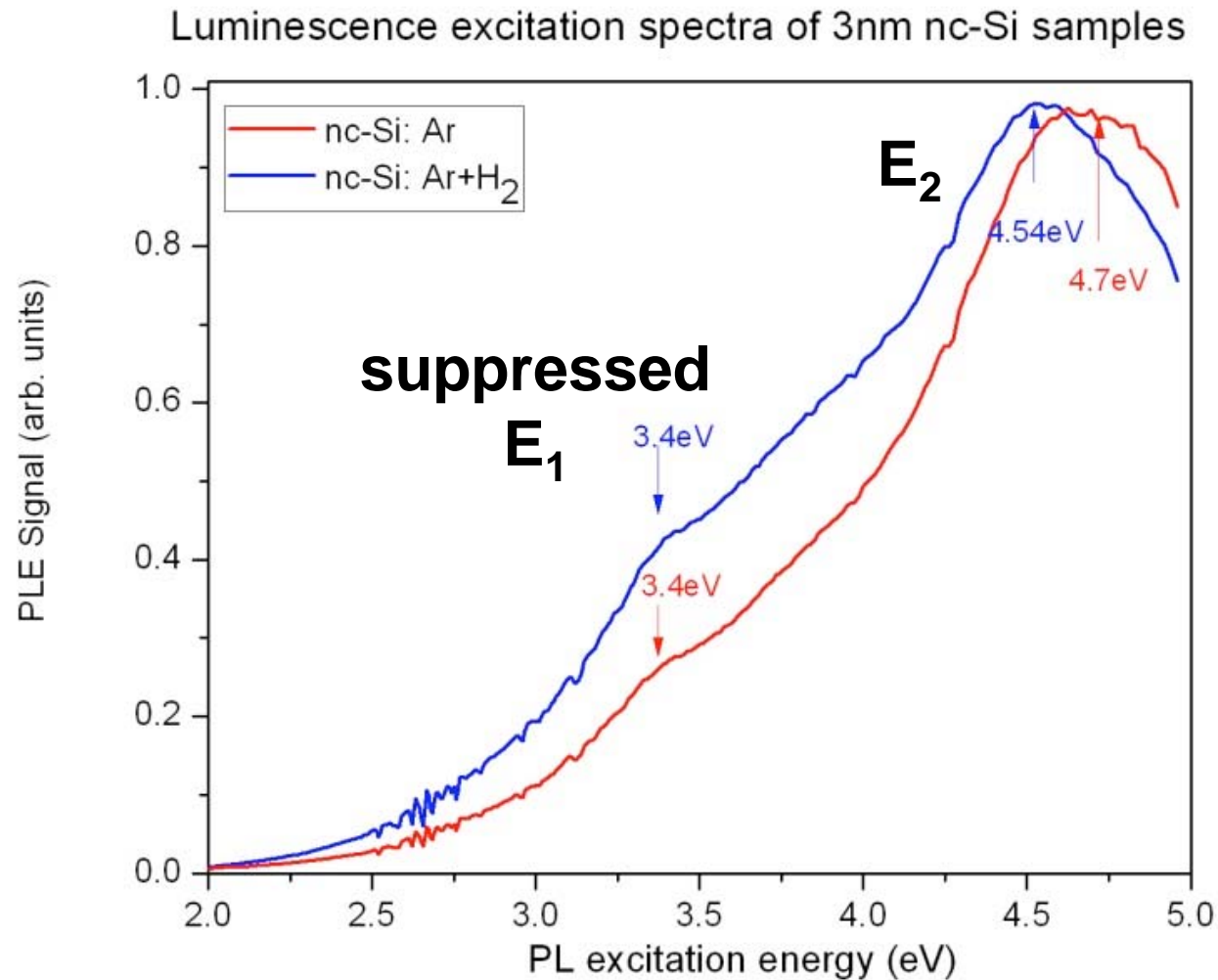
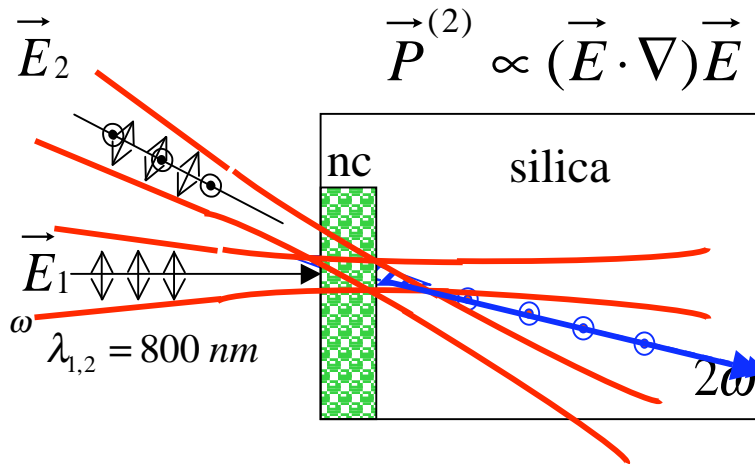


Photo-excited carriers cross-relax to interface states for PL

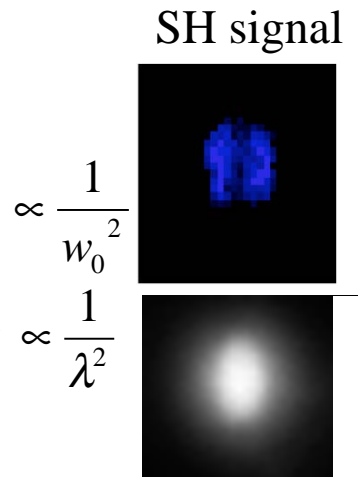
# Conventional single-beam SHG is weak

## Cross-Polarized 2-beam SHG (XP2-SHG) enhances signal 100×

Single beam SHG



XP2-SHG

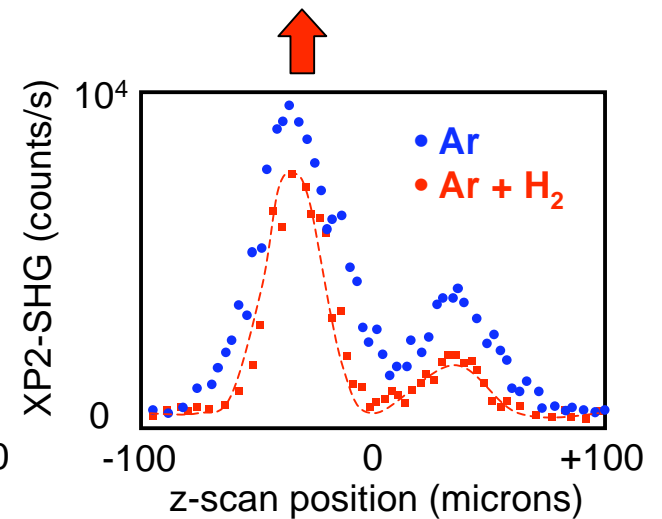
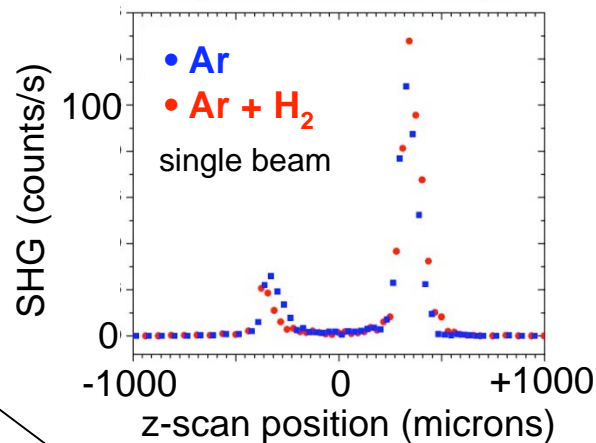
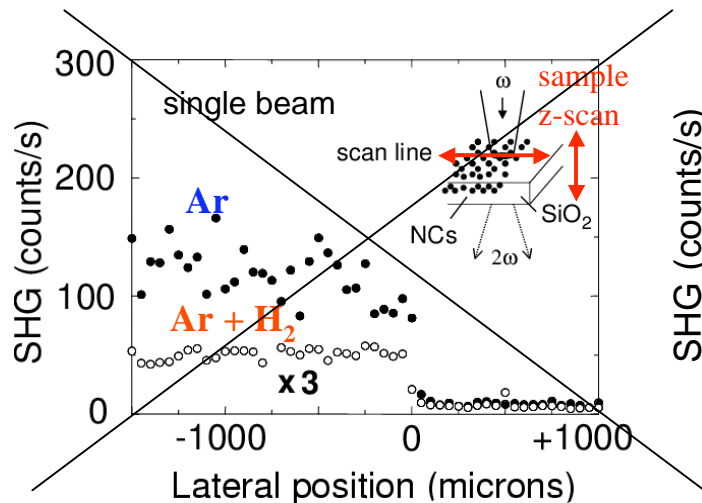


Three parameters needed to describe XP2-SHG response

$$\vec{P}_g^{(2)} \approx \underbrace{(\delta - \beta - 2\gamma)}_{\Gamma_g} (\vec{E} \cdot \nabla) \vec{E} + \dots$$

$$\vec{P}_{nc}^{(2)} \approx n_b (\gamma^e - \gamma^m - \gamma^q / 6) (\vec{E} \cdot \nabla) \vec{E} + \dots$$

$$\Gamma_{NC} = |\Gamma_{NC}| e^{i\phi}$$



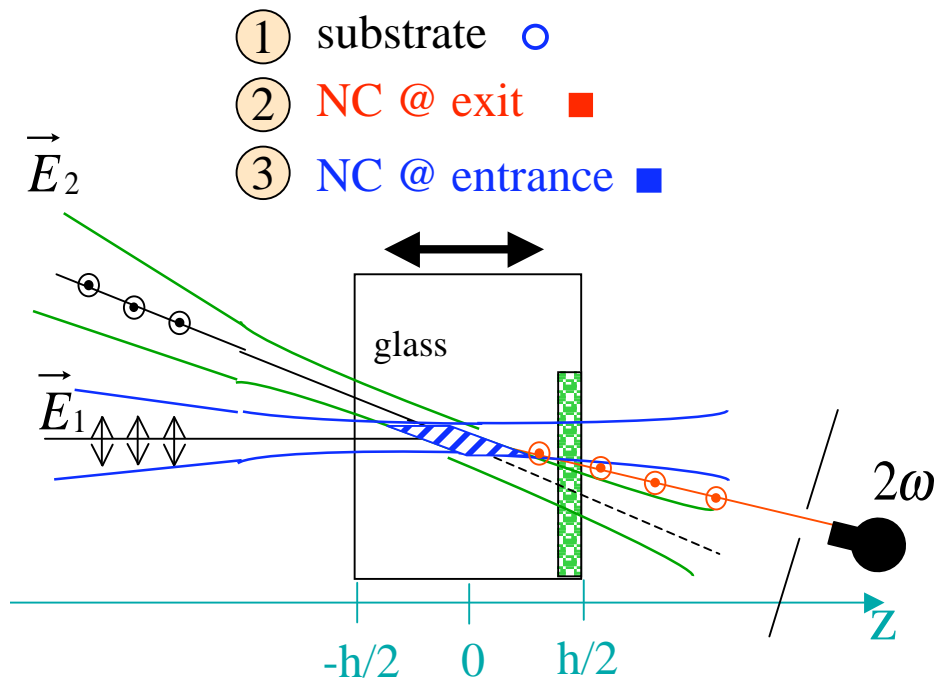
Jiang et al., Appl. Phys. Lett., **78**, 766 (2001)

L Sun et al, Opt. Lett, **30**, 2287 (2005)  
Figliozzi et al, Phy. Rev. Lett. **94**, 047401 (2005)

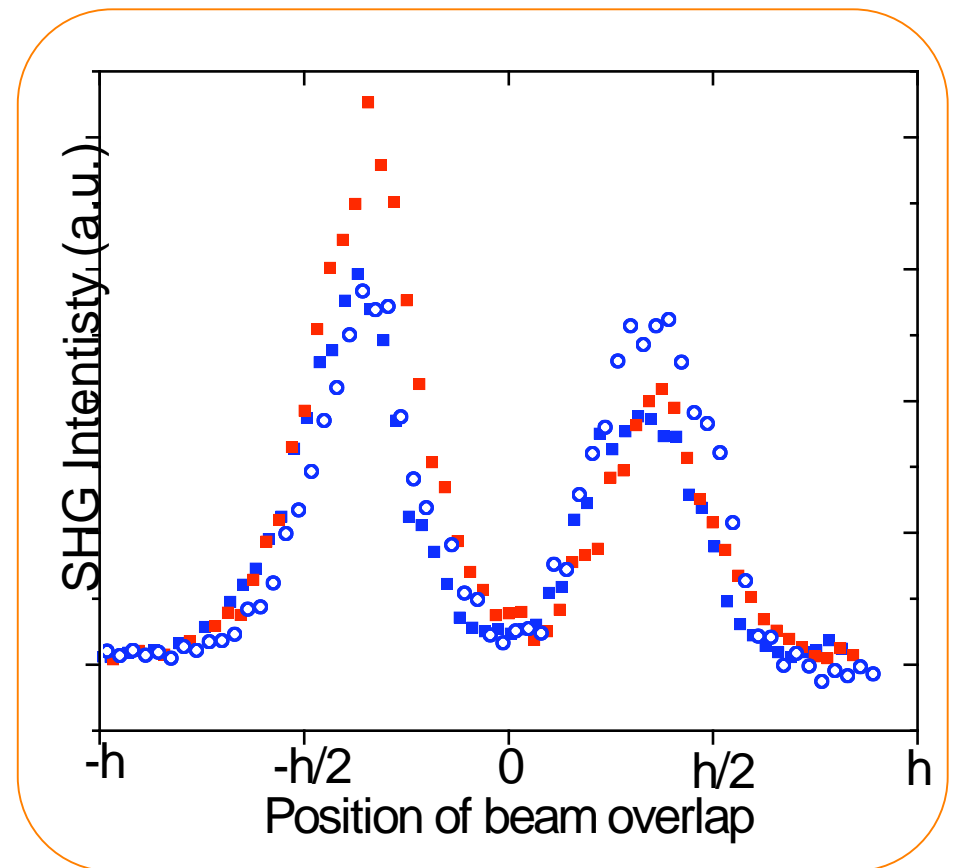
# Three independent z-scan measurements determine $\Gamma_g$ , $|\Gamma_{NC}|$ and $\phi$

- SHG signal growth in the glass is affected by phase mismatch
- The peaks result from relaxation of phase mismatch when boundaries of the sample fall within the 2-beam overlap region
- An analogous enhancement underlies 3rd harmonic microscopy with focused beams  
*Barad, Appl. Phys. Lett. 70, 922 (1997)*
- Peak heights are asymmetric because of linear absorption of SH light by NCs and interference of SHG signals generated by NCs and silica

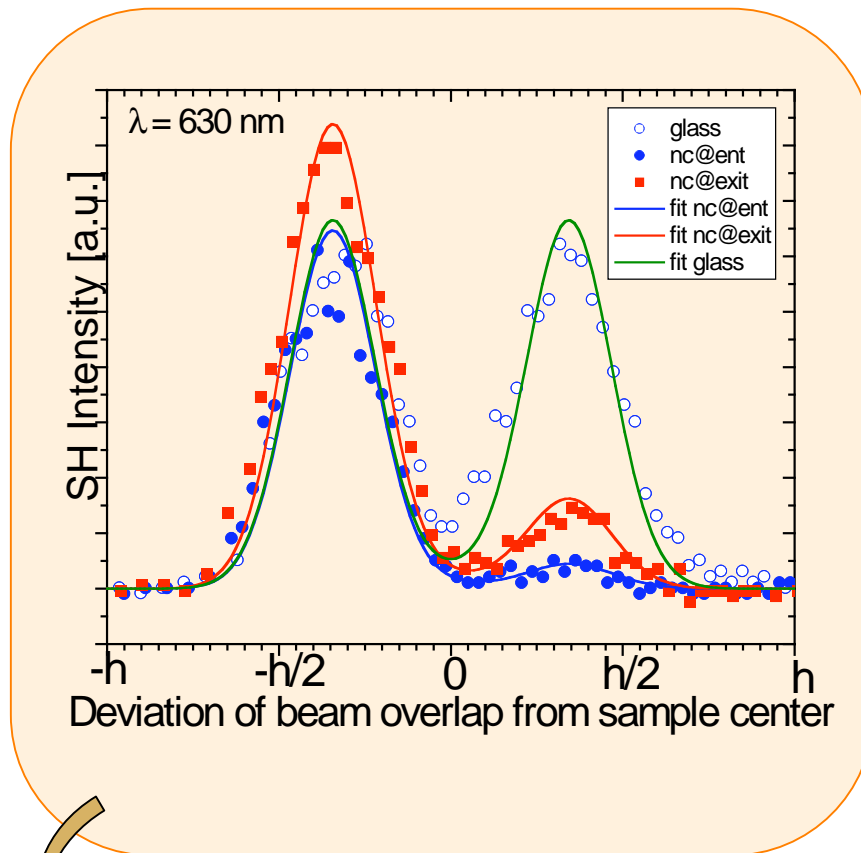
Measurements (scans):



L. Sun et al., *Optics Lett.* **30**, 2287 (2005)

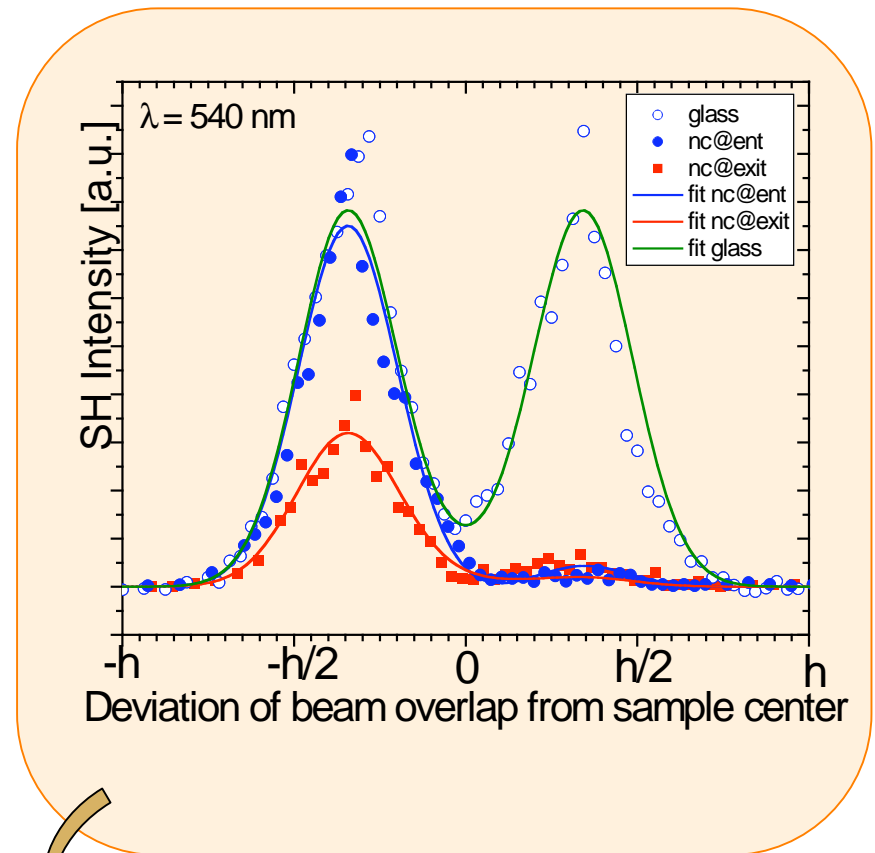


# Examples at 2 wavelengths illustrate extraction of fitting parameters $|\Gamma_{nc}|/\Gamma_g$ and $\phi$



$$\frac{|\Gamma_{nc}|}{\Gamma_g} = 1.743 \pm 0.064$$

$$\phi = (0.241 \pm 0.020)\pi$$

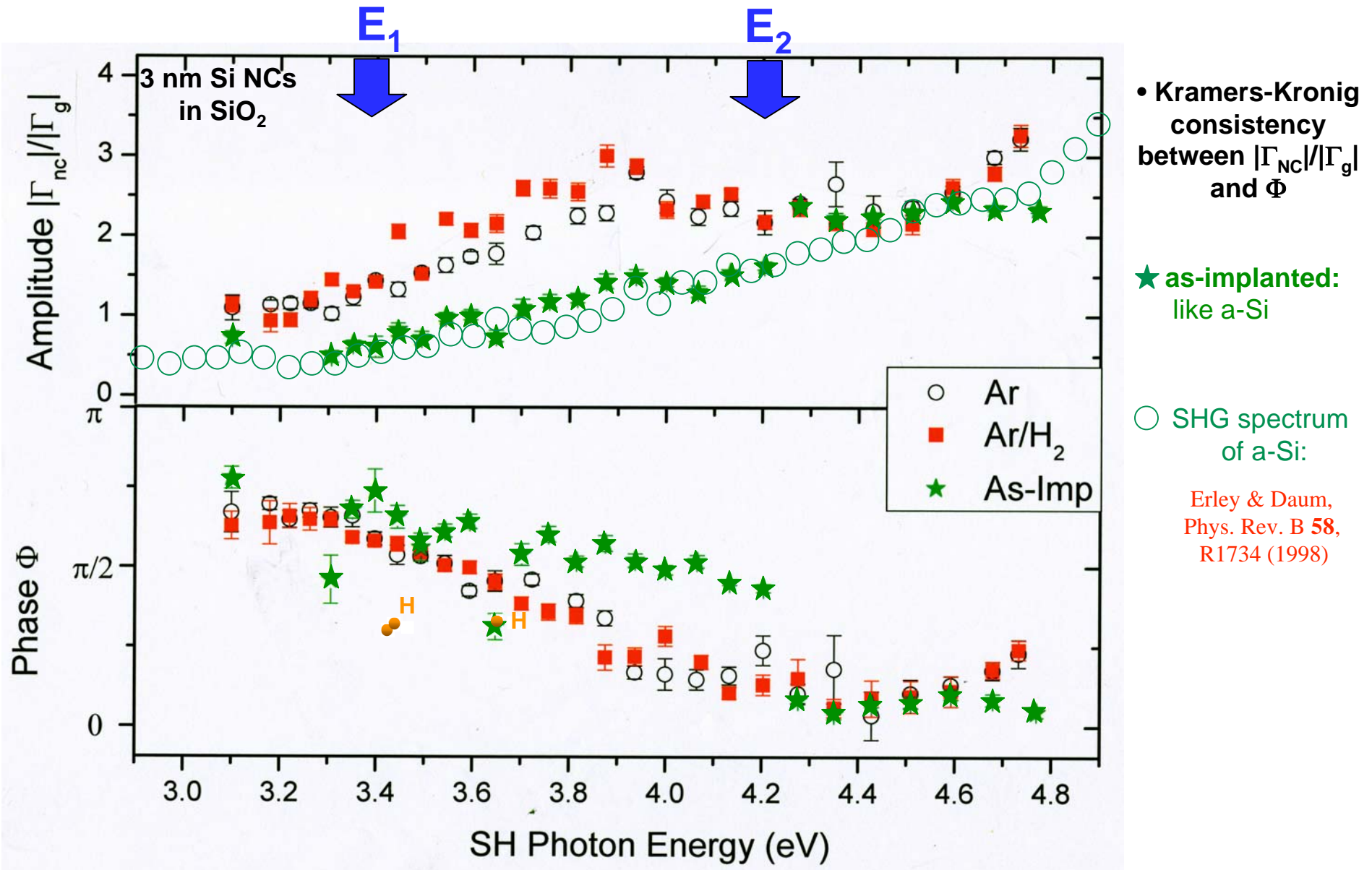


$$\frac{|\Gamma_{nc}|}{\Gamma_g} = 1.5217 \pm 0.060$$

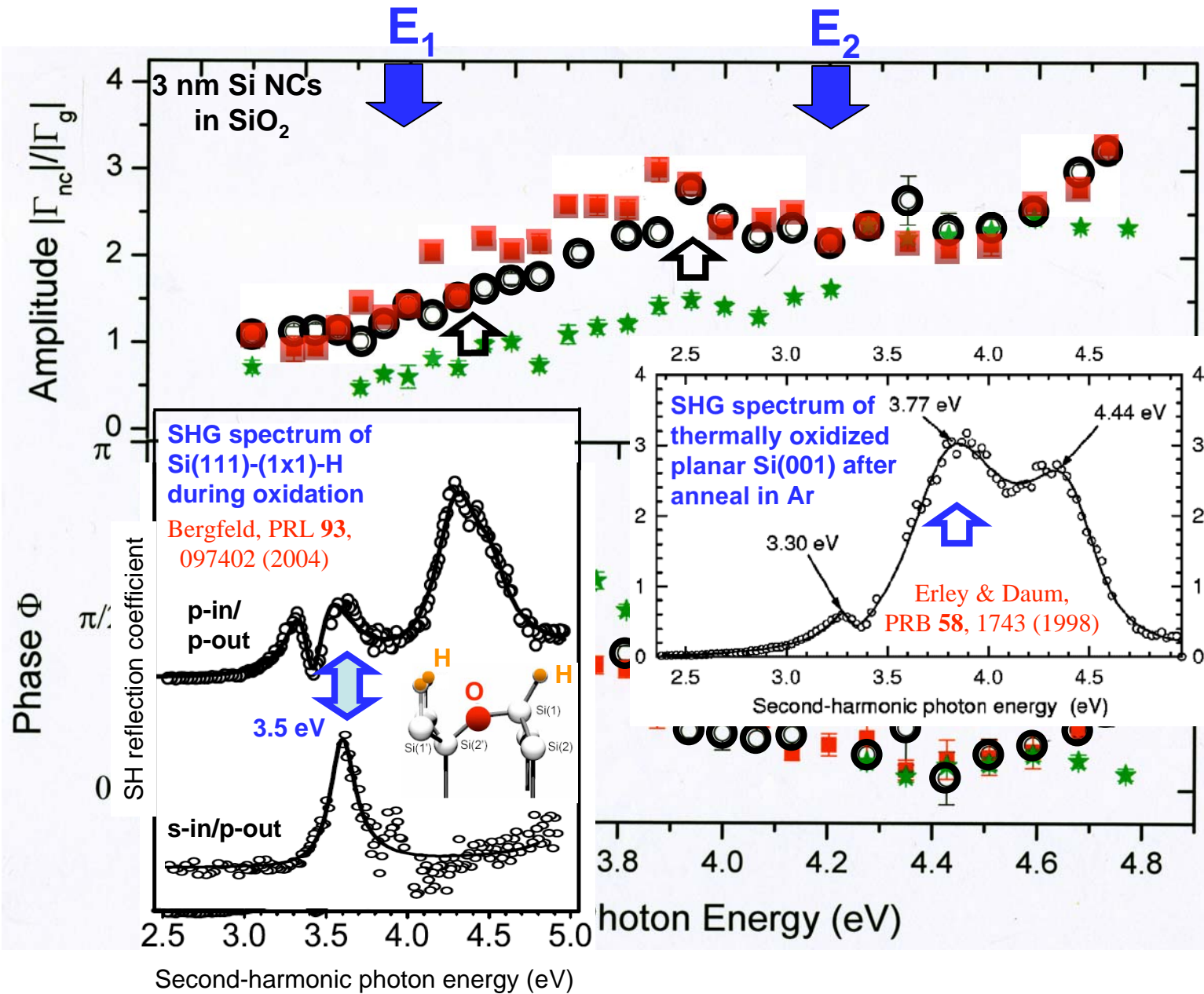
$$\phi = (0.159 \pm 0.040)\pi$$

**SE determined Fresnel factors used in this analysis**

# SHG spectra lack $E_{1,2}$ critical point resonances



# SHG spectra lack $E_{1,2}$ critical point resonances

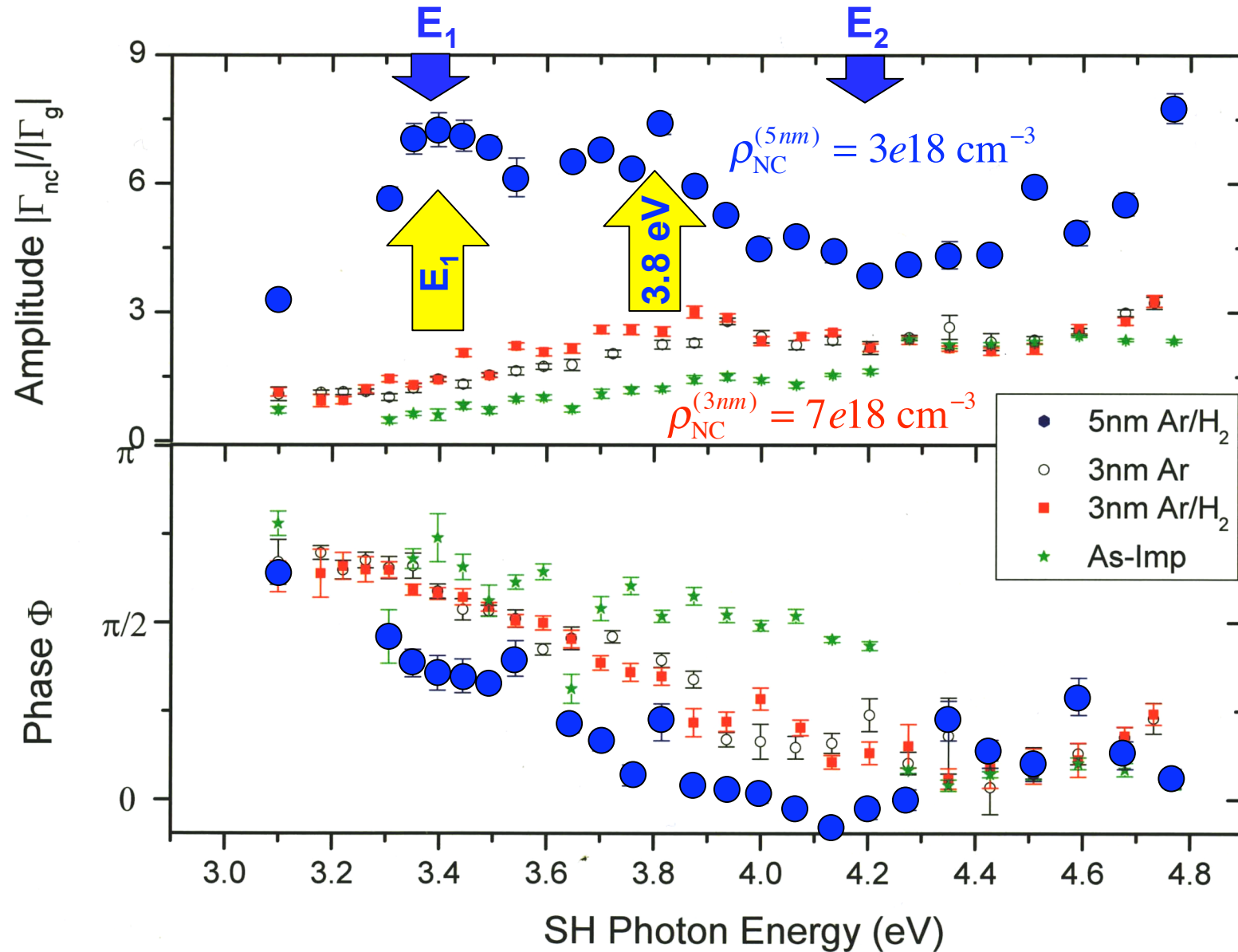


- annealed in Ar: enhanced  $\Gamma_{nc}$  near known SiO<sub>x</sub> resonances

- annealed in Ar/H<sub>2</sub>: minimal H-effect consistent with previous SHG

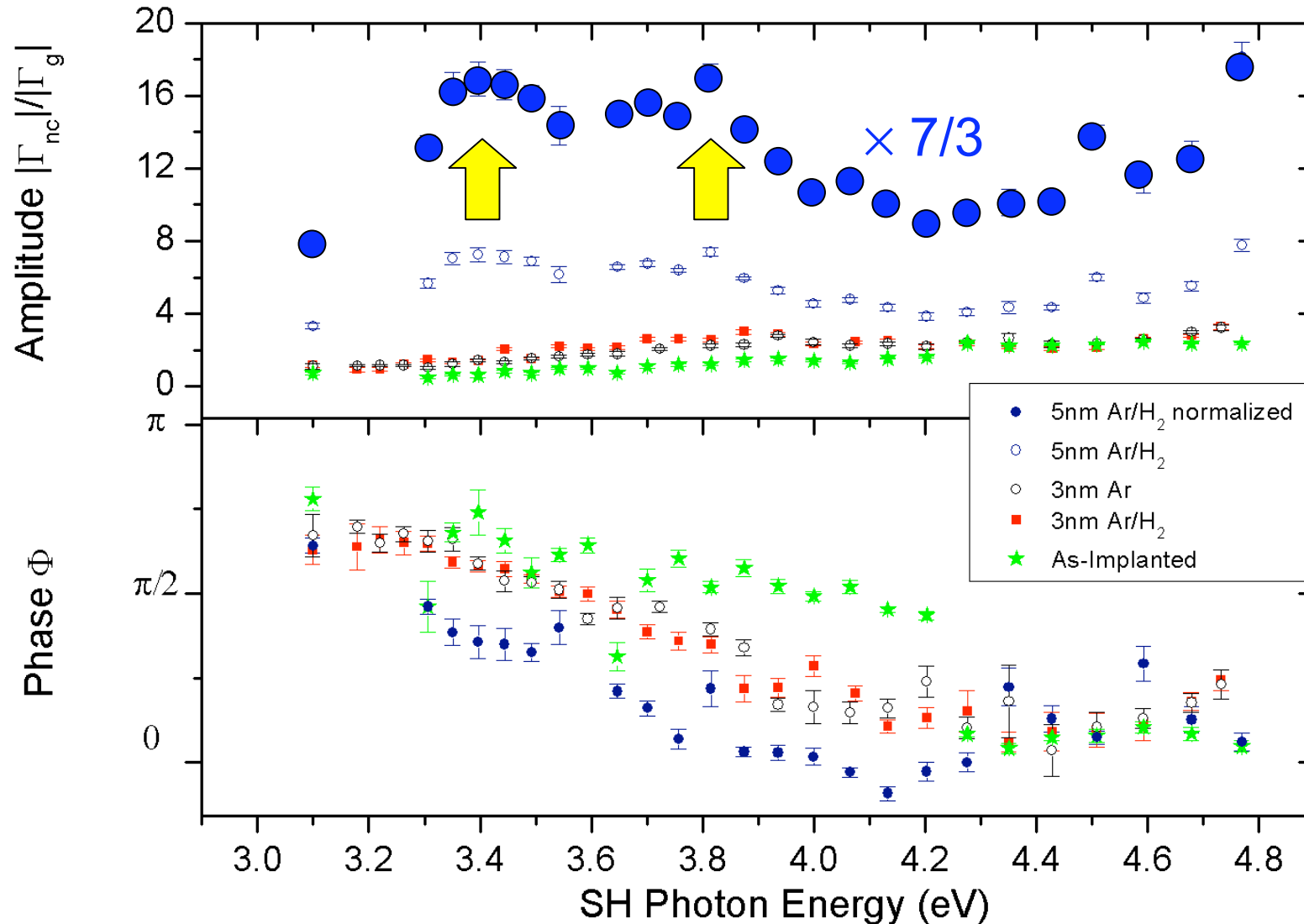


# $E_1$ (3.4 eV) and 3.8 eV resonances appear in SHG spectra of 5 nm diameter Si NCs



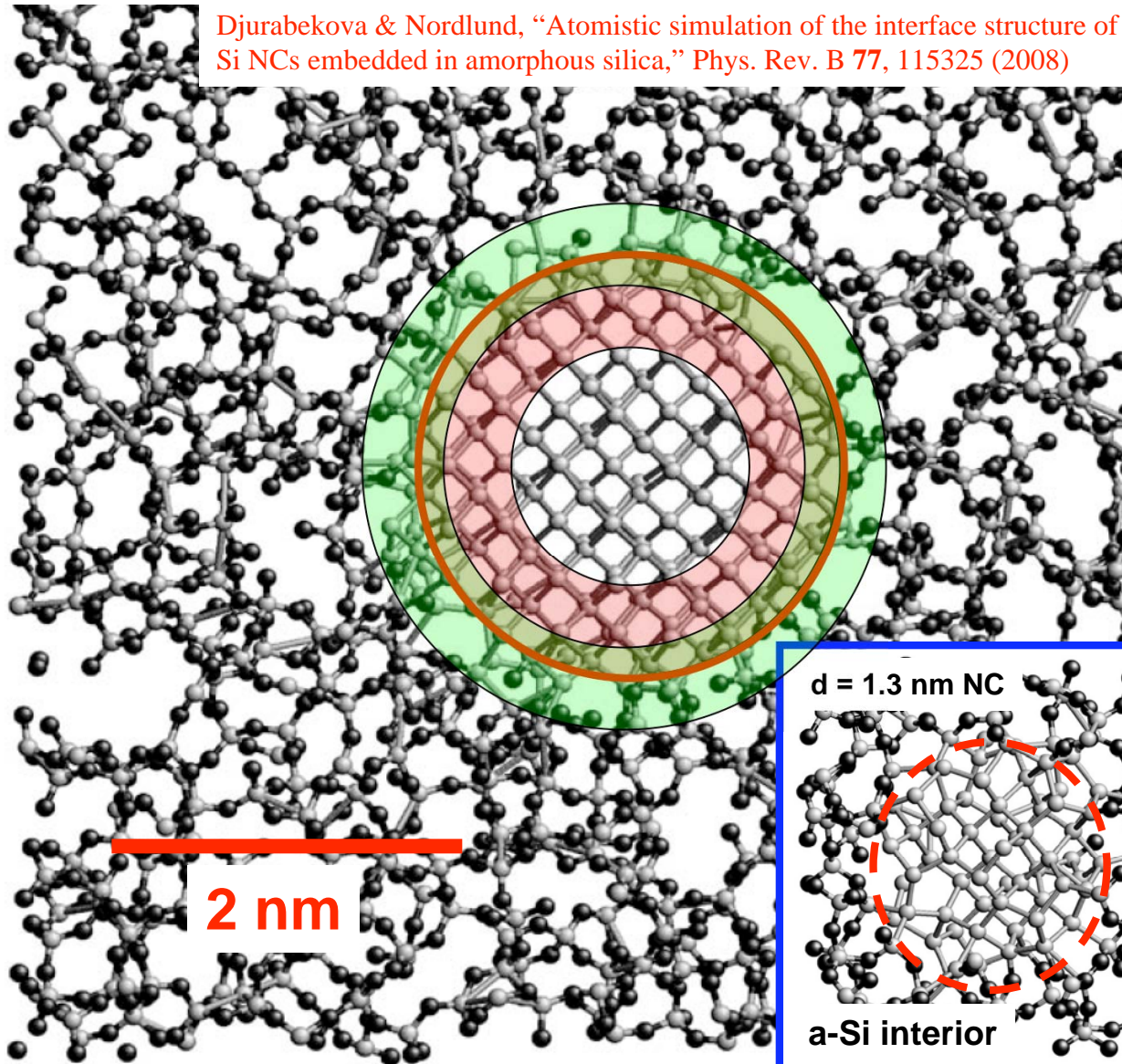
# SHG per NC is $>10\times$ stronger from 5 nm NCS than from 3 nm NCs

Ideal single particle SHG scaling:  $(5/3)^6 = 21$  [Dadap, PRL (1999)]



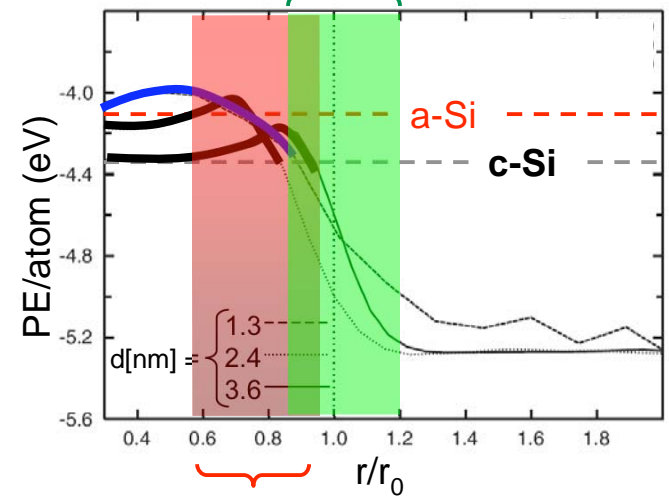
# Spectroscopic XP2-SHG is sensitive to nc-Si/SiO<sub>2</sub> interfacial features\* not observed by other spectroscopies that appear in recent MD simulations

Djurabekova & Nordlund, "Atomistic simulation of the interface structure of Si NCs embedded in amorphous silica," Phys. Rev. B **77**, 115325 (2008)



~ 10% undercoordinated bonds, Si=O bonds also present

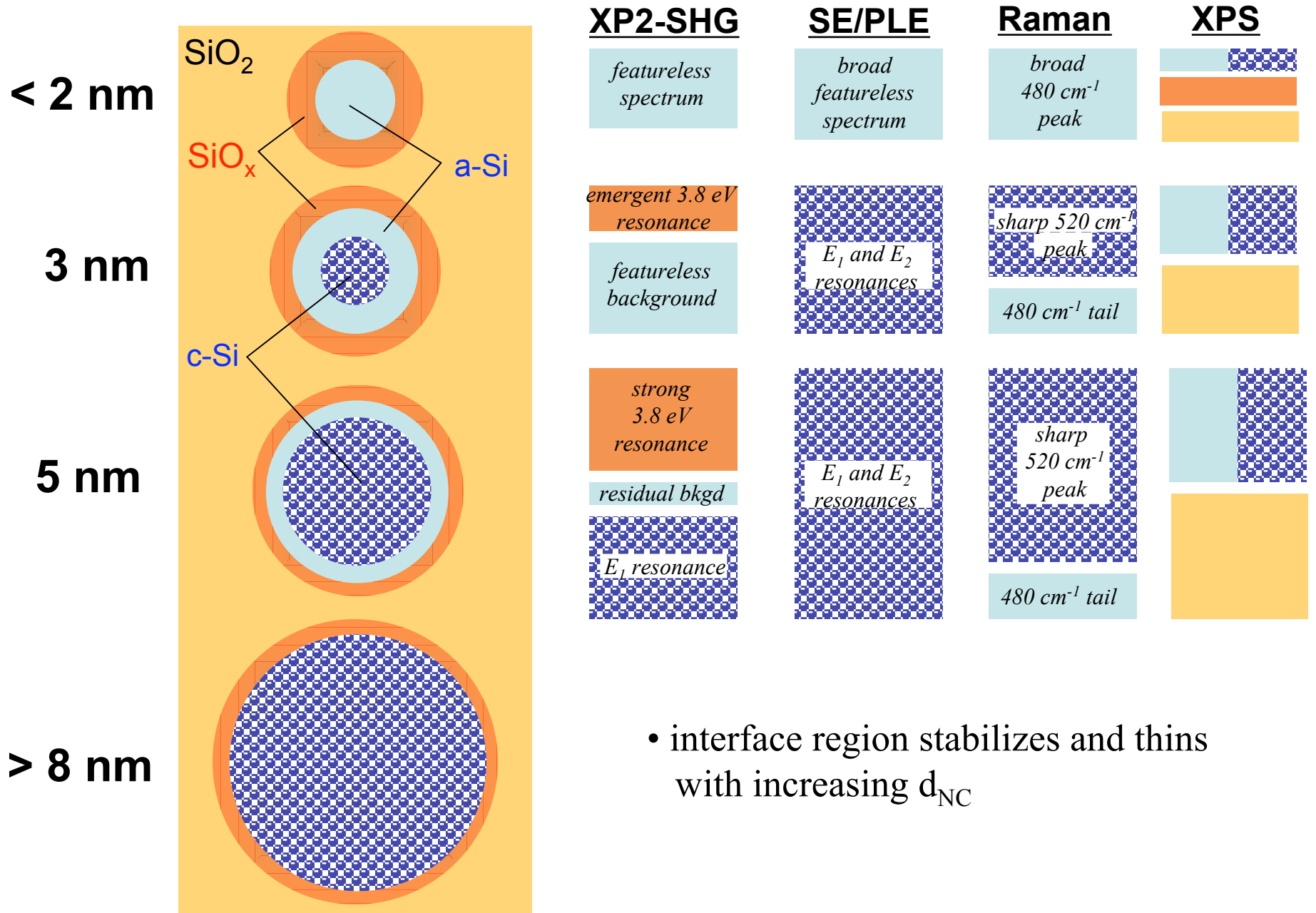
~ 10% suboxide\*



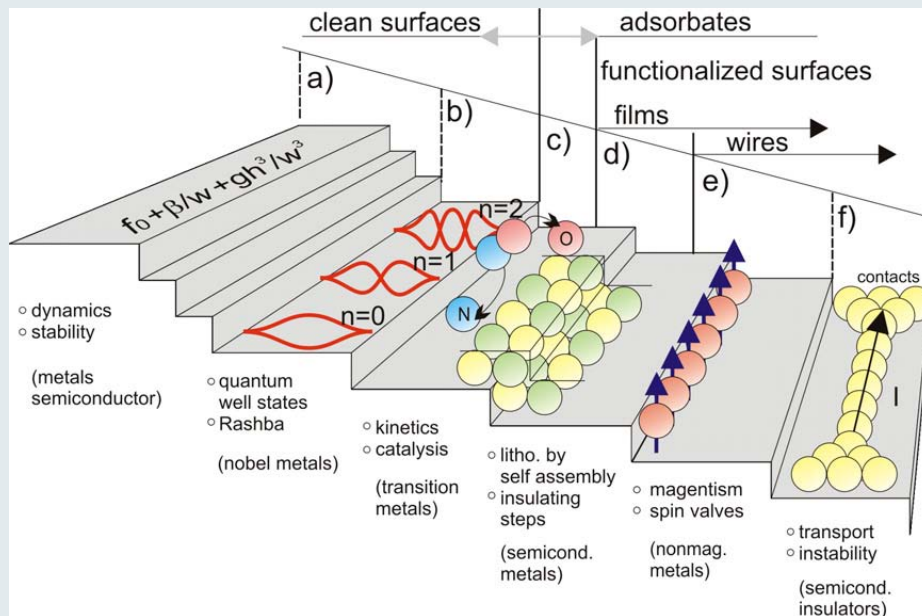
\*elevated PE/atom  
⇒ a-Si shell

S-SHG validates & guides simulations of the nc-Si/SiO<sub>2</sub> interface

# Conclusions about Si embedded nanocrystals



# Stepped (vicinal) Si surfaces are attractive templates for nanofabrication



- investigation of step-enhanced chemical reactions
- atomic wires suitable for transport
- “lithography” by self assembly of nanostructures
- ...

**Non-invasive in-situ sensors that provide atomic-scale information over the dimensions of a wafer are needed**

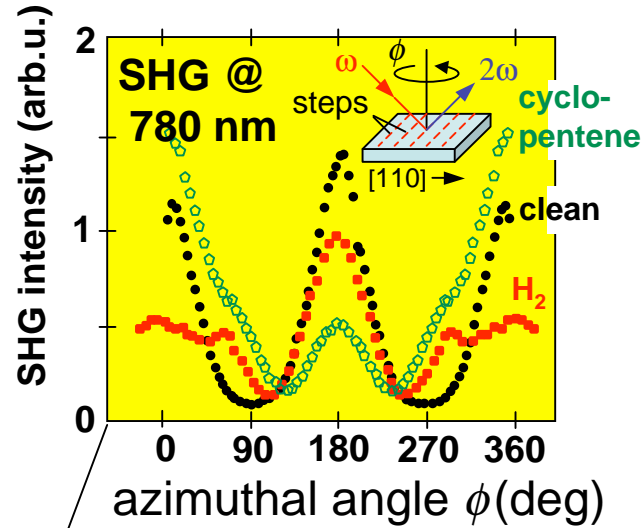
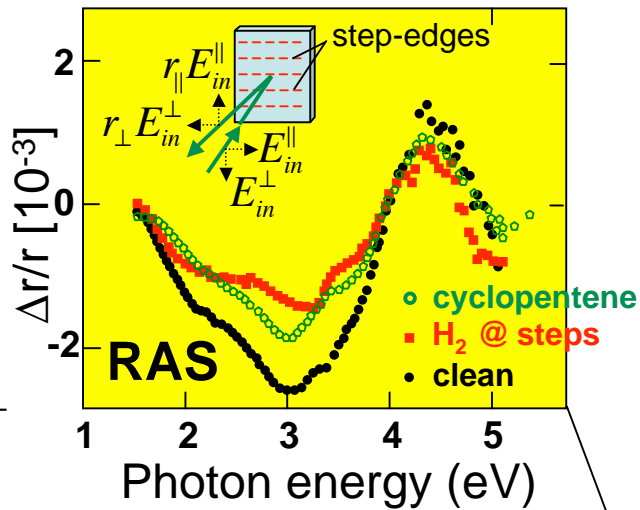
# Optical metrology bridges the nano-scale & wafer-scale

Aspnes & Studna, PRL 54, 1956 (1985)

Reflectance  
Anisotropy  
Spectroscopy

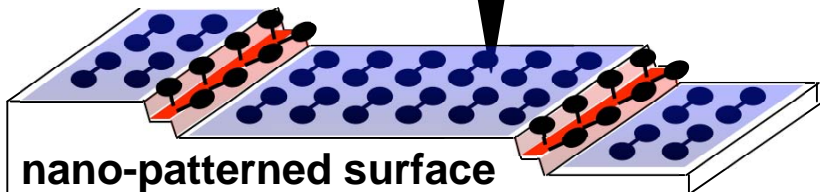
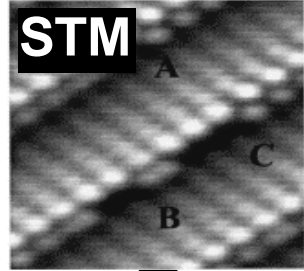
$$r_{\perp} \neq r_{\parallel}$$

$$\frac{\Delta\tilde{r}}{\tilde{r}} = 2 \frac{\tilde{r}_{\perp} - \tilde{r}_{\parallel}}{\tilde{r}_{\perp} + \tilde{r}_{\parallel}}$$



*optical metrology*

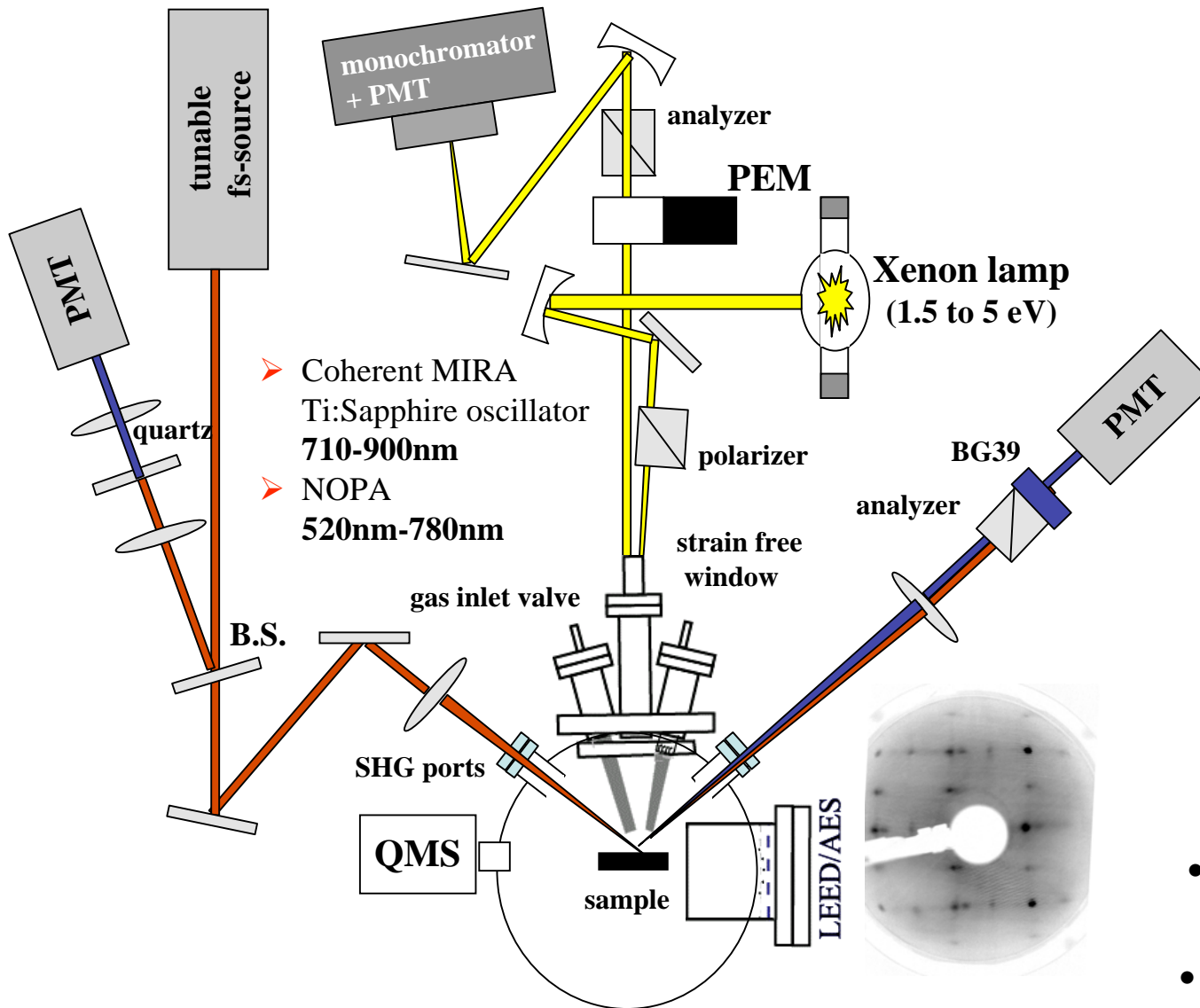
*nano-scale probe*



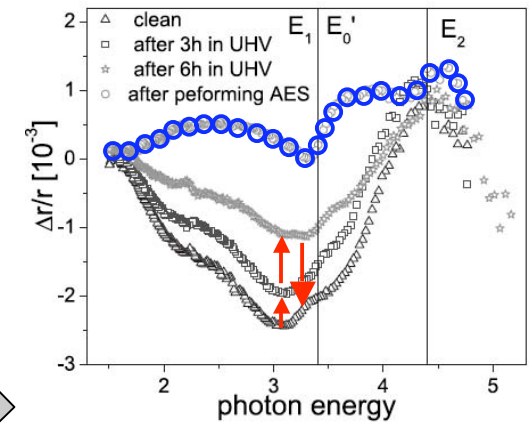
*wafer-scale nanomanufacturing*



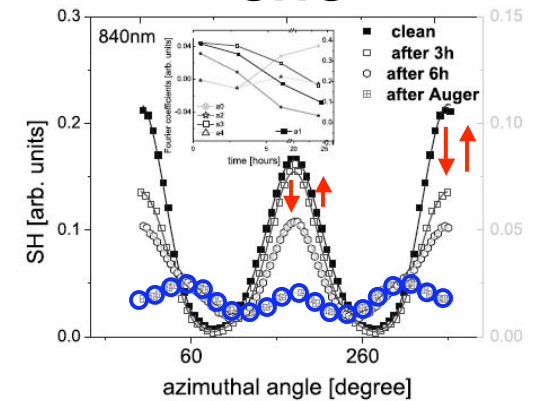
# We combine SHG & RAS probes of stepped Si(001) surfaces in UHV



## RAS



## SHG



- RAS & SHG track contamination non-invasively
- completely reversible

# We have studied 3 very different surface chemical reactions on Si(001):6°

## 1) H<sub>2</sub>

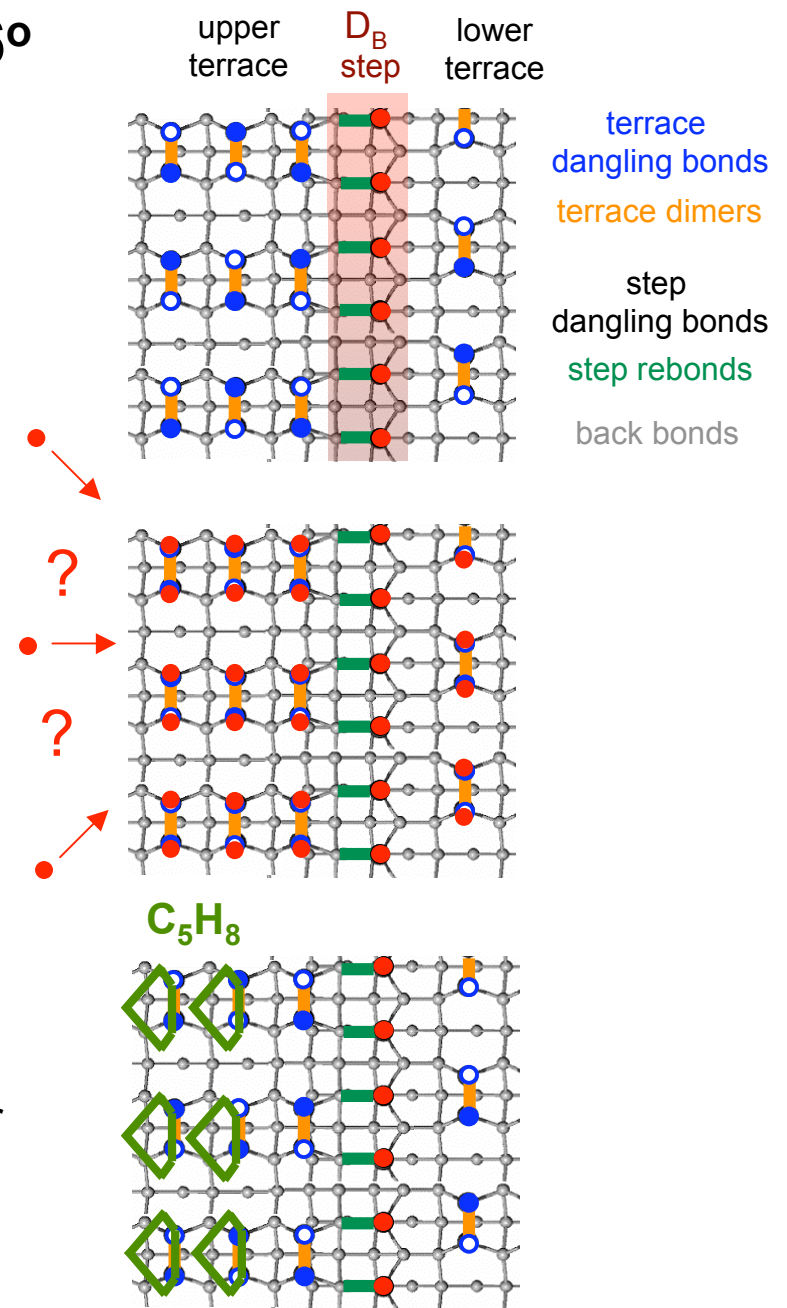
- ~ 1000 L H<sub>2</sub> @ 150 C
- bonds selectively to step-edge db's
- Dürr *et al.*, Phys. Rev. B **63**, 121315 (2001)

## 2) H<sub>2</sub> + atomic H

- ~ 10<sup>6</sup> L H<sub>2</sub> (saturation dose)
- passivates step AND terrace db's, leaving steps and dimers intact
- atomic H can react with step rebonds and/or terrace dimers. Which happens first?

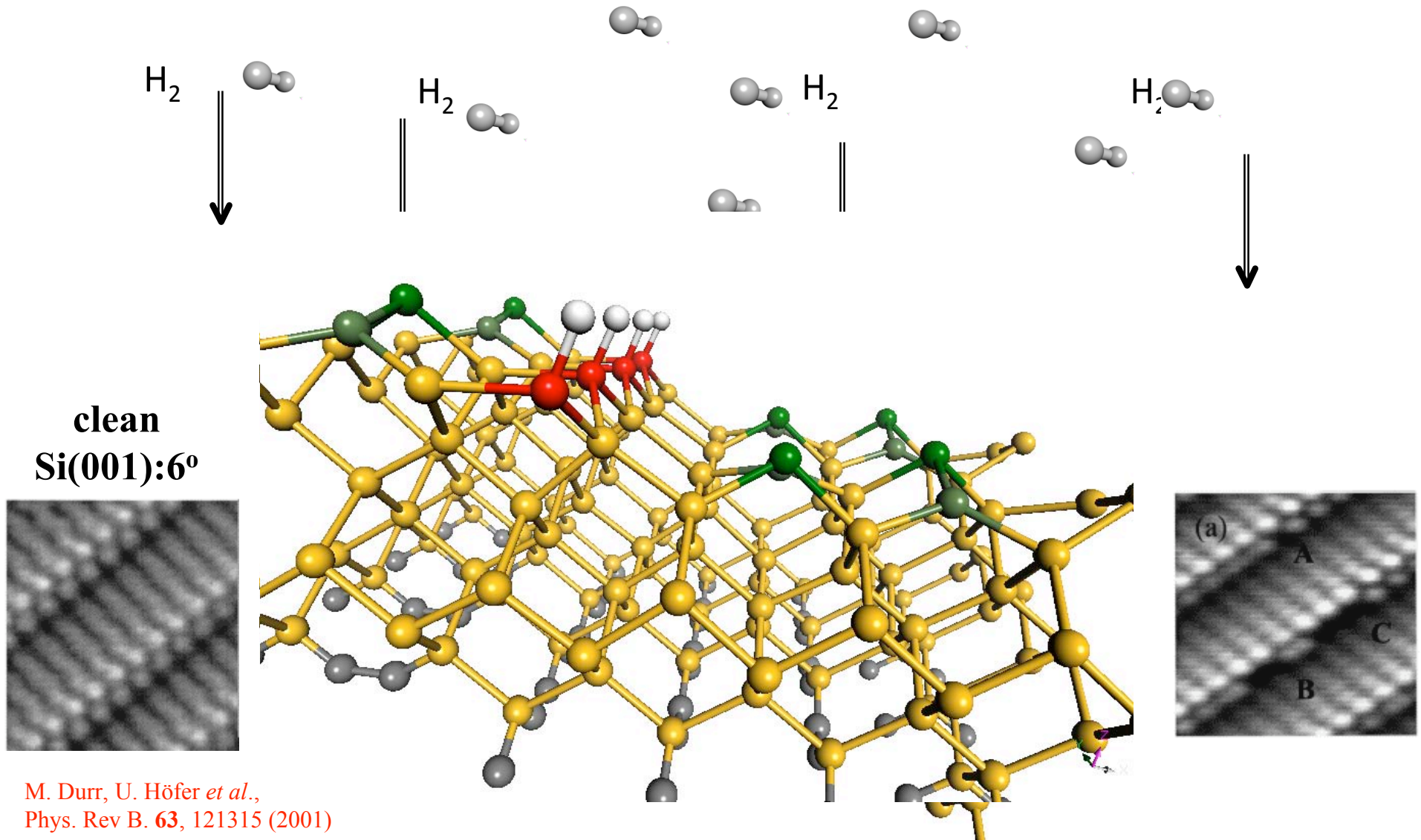
## 3) H<sub>2</sub> + C<sub>5</sub>H<sub>8</sub> (cyclopentene)

- C<sub>5</sub>H<sub>8</sub> bonds by 2+2 cycloaddition to terrace dimers, forming crystalline organic monolayer
- step-adsorbed H may help modify & control C<sub>5</sub>H<sub>8</sub> adsorption



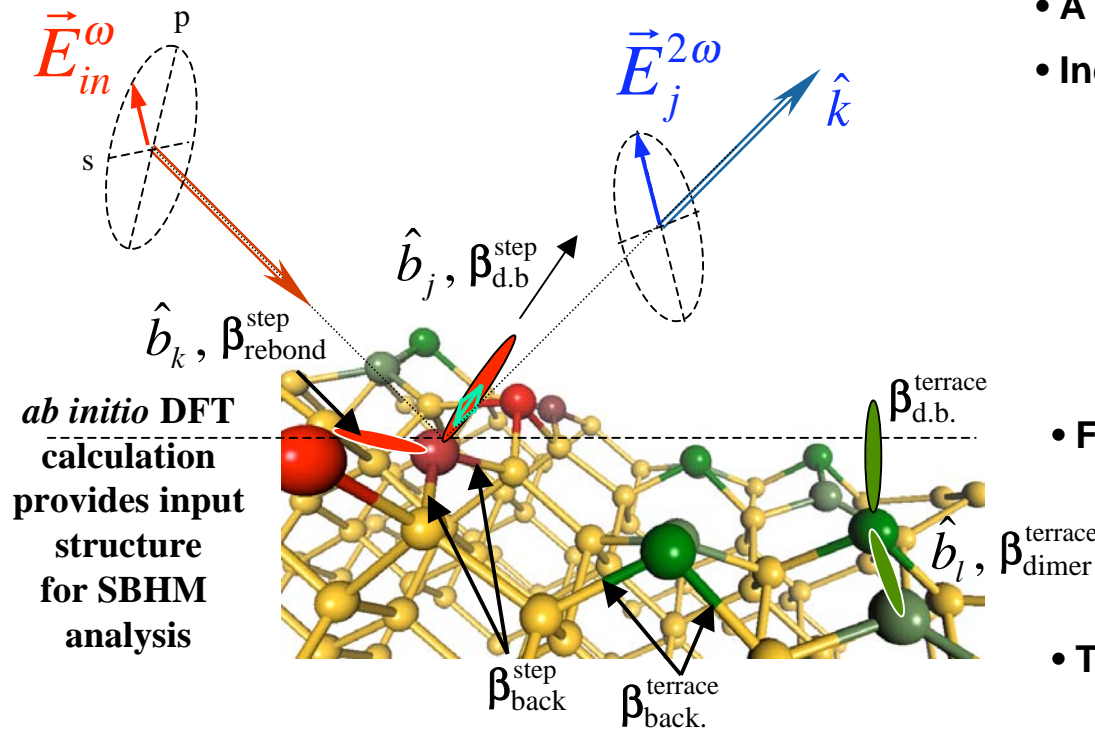


# SHG/RAS Case Study #1: Dissociative adsorption of $H_2$ at $D_B$ steps of $Si(001):6^\circ$



# In the absence of first principles theory, Simplified Bond Hyperpolarizability Model (SBHM) provides SHG - RAS interpretation at the molecular bond level

Powell *et al.*, Phys. Rev. B **65**, 205320 (2002)



- A chemical bond is the basic polarizable unit
- Induced axial SH polarization of bond  $j$ :

$$\vec{p}_j^{(2\omega)} = \beta_j^{\parallel} \hat{b}_j (\hat{b}_j \cdot \vec{E}_{in}^{\omega})^2$$

$\hat{b}_j$  = bond unit vector

$\beta_j^{\parallel}$  = axial hyperpolarizability

- Far-field SH radiation of bond  $j$ :

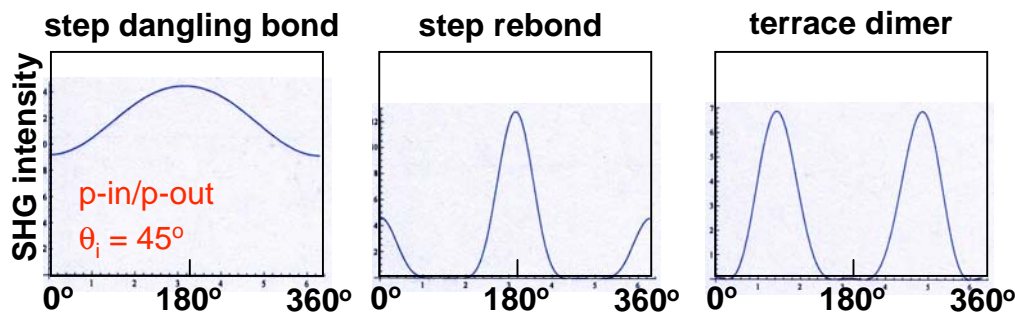
$$\vec{E}_j^{2\omega} = \frac{e^{ikr}}{r^2} (\vec{I} - \hat{k}\hat{k}) \cdot \vec{p}_j^{(2\omega)}$$

- Total far-field SH radiation:

$$\vec{E}_j^{2\omega} = \frac{e^{ikr}}{r^2} (\vec{I} - \hat{k}\hat{k}) \cdot \sum_j \vec{p}_j^{(2\omega)}$$

- Simplifications:

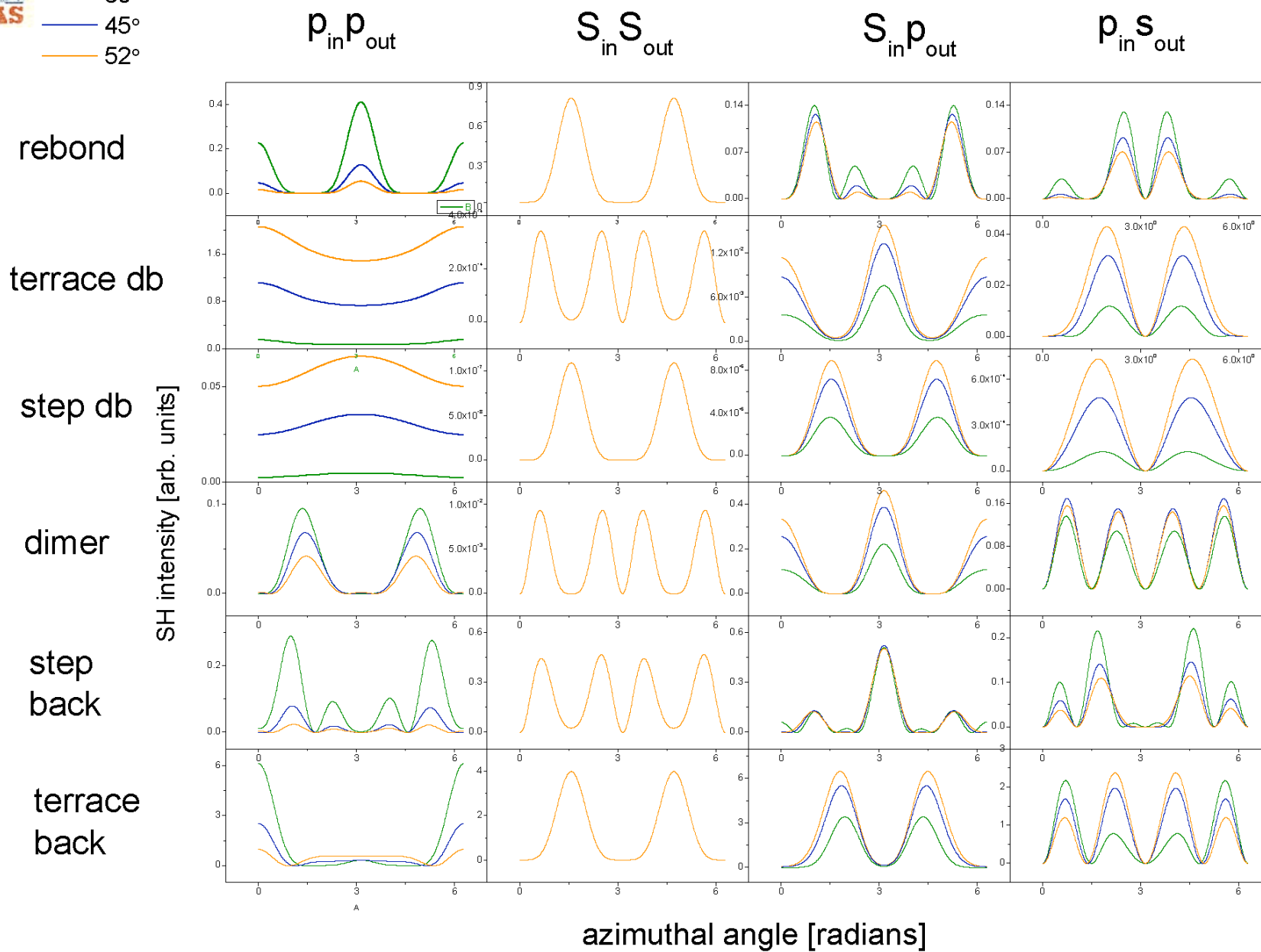
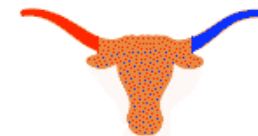
- transverse hyperpolarizabilities neglected
- local field corrections folded into  $\beta$ 's
- boundary conditions not treated rigorously





— 30°  
— 45°  
— 52°

# SHG “dictionary” for Si(001): 6°



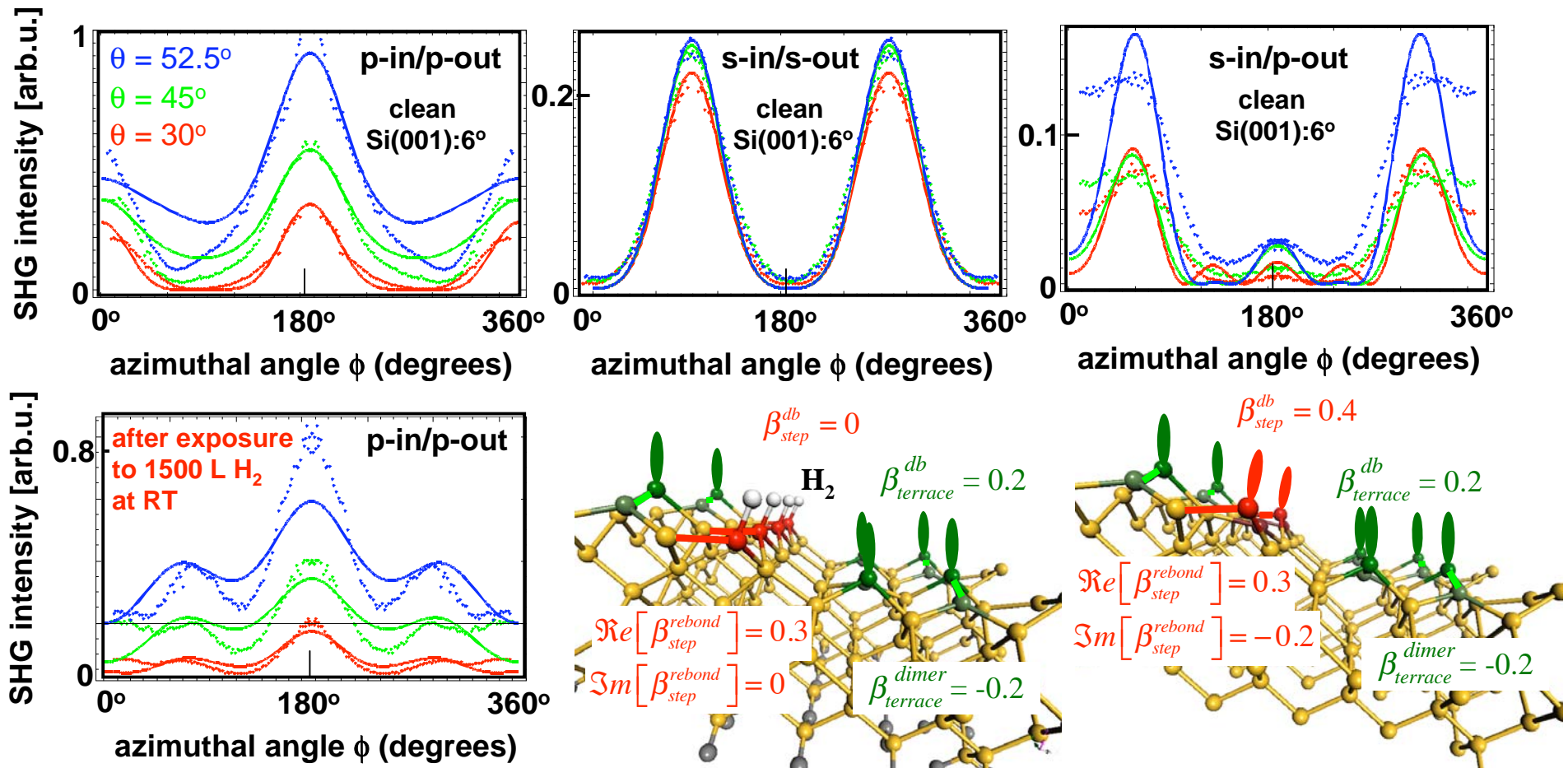
# Multi-parameter fitting (like Wall St. investing) requires “government regulation” based on...

... Bond physics & chemistry

... Kramers-Kronig consistency

Bonds that are parallel to  $\mathbf{E}^\circ$ , charge-rich and non-centrosymmetric contribute most strongly

.. Consistency for Multiple Angles ( $\theta$ ) and Polarizations (MAP)



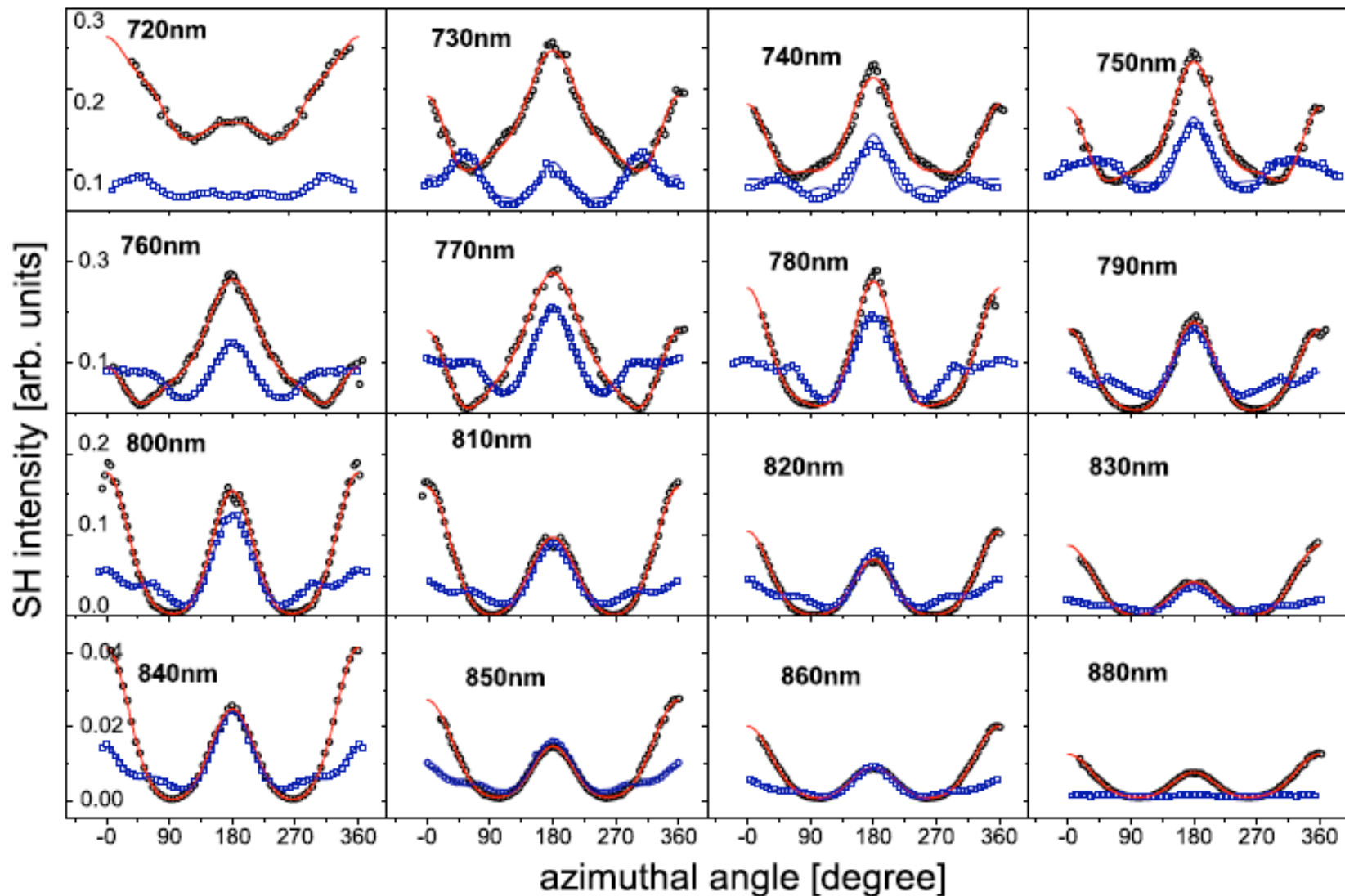
# Full SBHM fits SHG data with high fidelity

clean Si(001): 6°

Si(001): 6° with H-terminated steps

$\theta = 42^\circ$

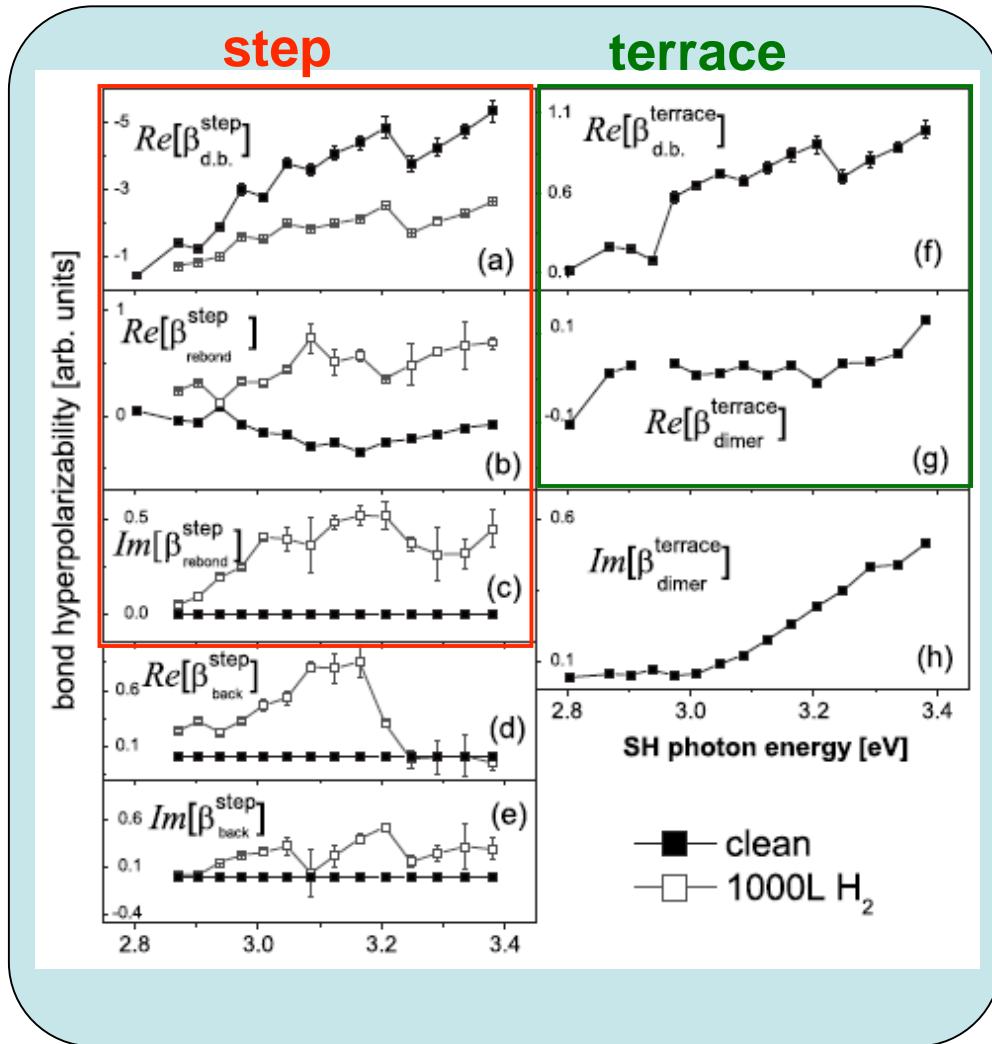
p-in/p-out



# Strict regulation: derive RAS response from SHG data

Fitted bond hyperpolarizability spectra  $\beta_j^{\parallel}$

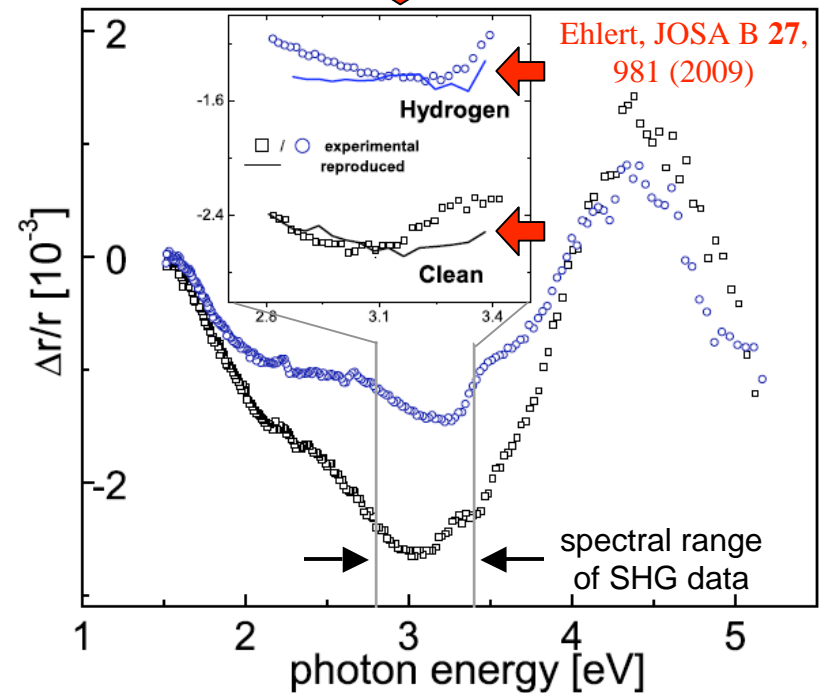
linear bond polarizabilities



\*Miller's theorem:  $\beta_j^{\parallel} = \Delta \alpha_{j,2\omega}^{\parallel} \alpha_{j,\omega}^{\parallel} \alpha_{j,\omega}^{\parallel}$

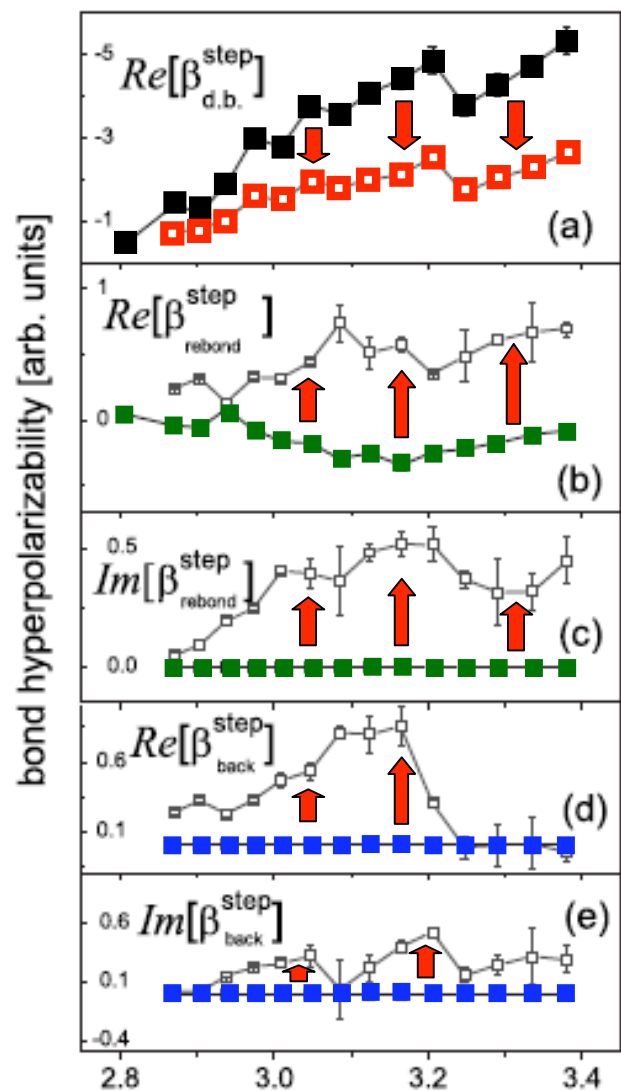
$$\vec{E}_{linear}^{2\omega} \propto (\hat{I} - \hat{k}\hat{k}) \cdot \sum_j \alpha_{j,2\omega}^{\parallel} \hat{b}_j \hat{b}_j \cdot \vec{E}_{in}^{2\omega}$$

$$\frac{\tilde{r}_{1\bar{1}0} - \tilde{r}_{110}}{\tilde{r}}$$

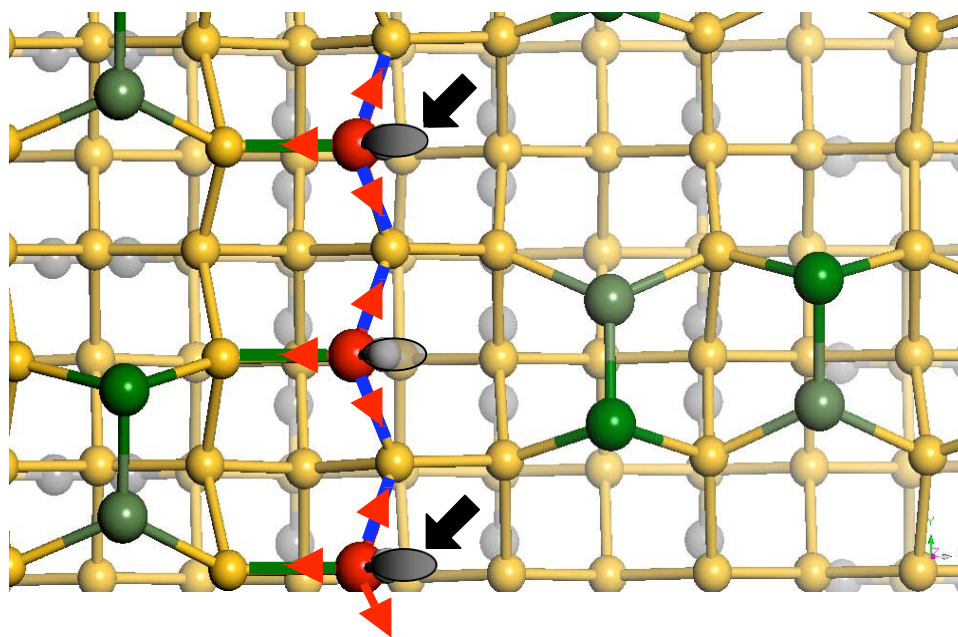


\*R. C. Miller, Appl. Phys. Lett. 5, 17 (1964)

# Hyperpolarizability spectra show charge transfer from step dangling bond to 3 underlying bonds when H<sub>2</sub> dissociatively adsorbs at step-edges



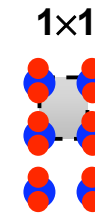
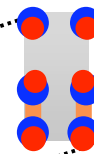
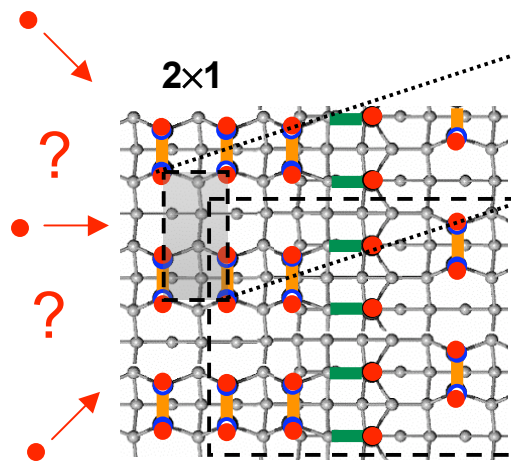
■ clean  
□ 1000 L H<sub>2</sub>



With SHG-RAS-SBHM, we watch charge transfer accompanying the formation of specific step-edge chemical bonds.

# SHG/RAS/SBHM Case Study #2: Reaction of atomic H with H<sub>2</sub>-saturated Si(001):6° surface

1000 L H<sub>2</sub> × 1000

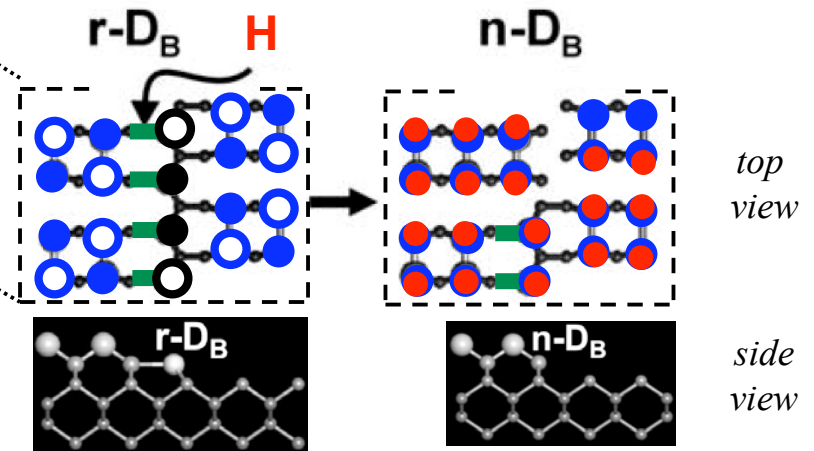


- 2×1 monohydride terraces convert to 1×1 dihydride, breaking dimers

*Borenzstein et al., Phys. Rev. Lett.* **95**, 117402 (2005)

- symmetrized dimers
- 2×1-reconstructed terraces
- re-bonded (r) D<sub>B</sub> steps intact

*Pehlke & Kratzer, Phys. Rev. B* **59**, 2790 (1999)

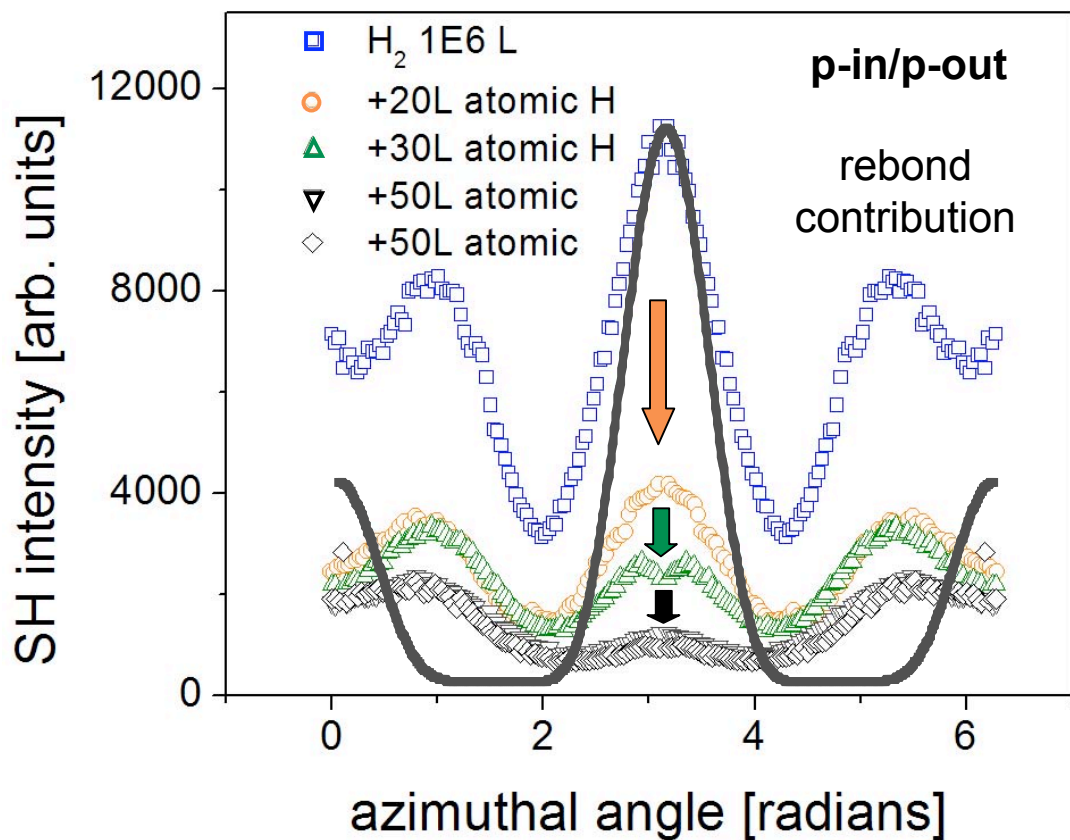


- atomic H catalyzes conversion of r-D<sub>B</sub> to non-rebonded D<sub>B</sub>, S<sub>B</sub> and S<sub>A</sub> steps

*Laracuenta & Whitman, Surf. Sci.* **545**, 70 (2003)

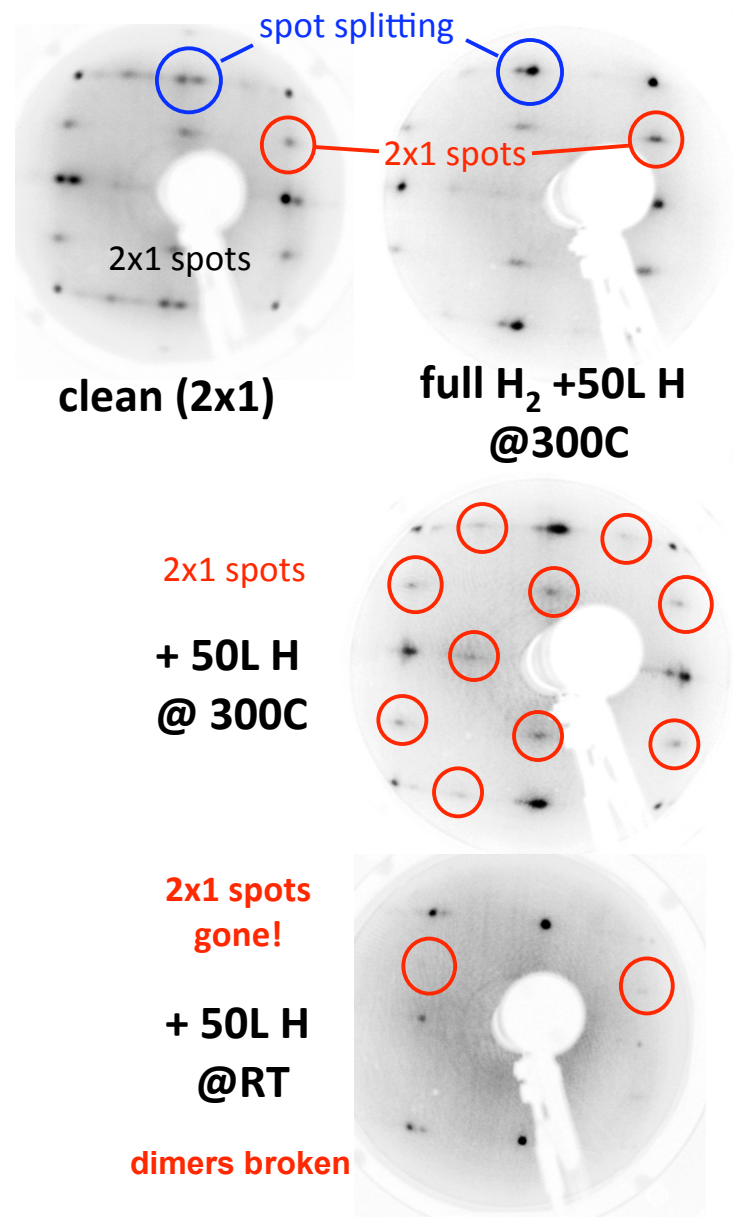


# SHG: Rebonds break immediately



**No remaining SHG signature of rebond after ~ 100 L atomic H**

# LEED: Dimers break later

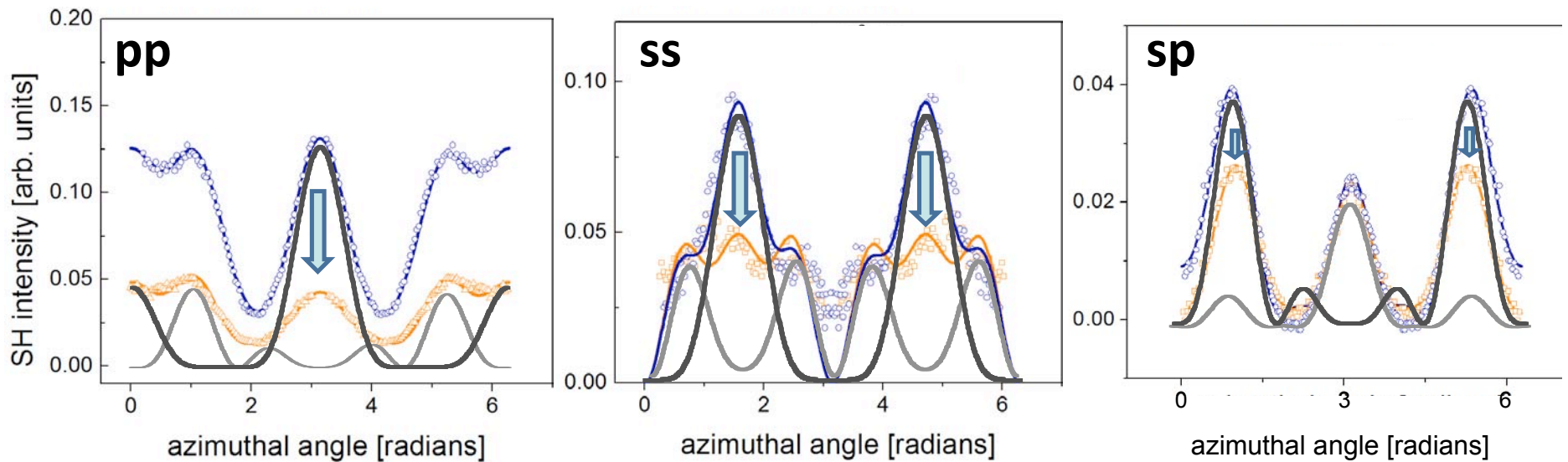


# SHG-MAP shows decreasing rebond, increasing backbond, expression during H exposure

—○—  $1 \times 10^6$  L  $H_2$

—△— + 50 L atomic H

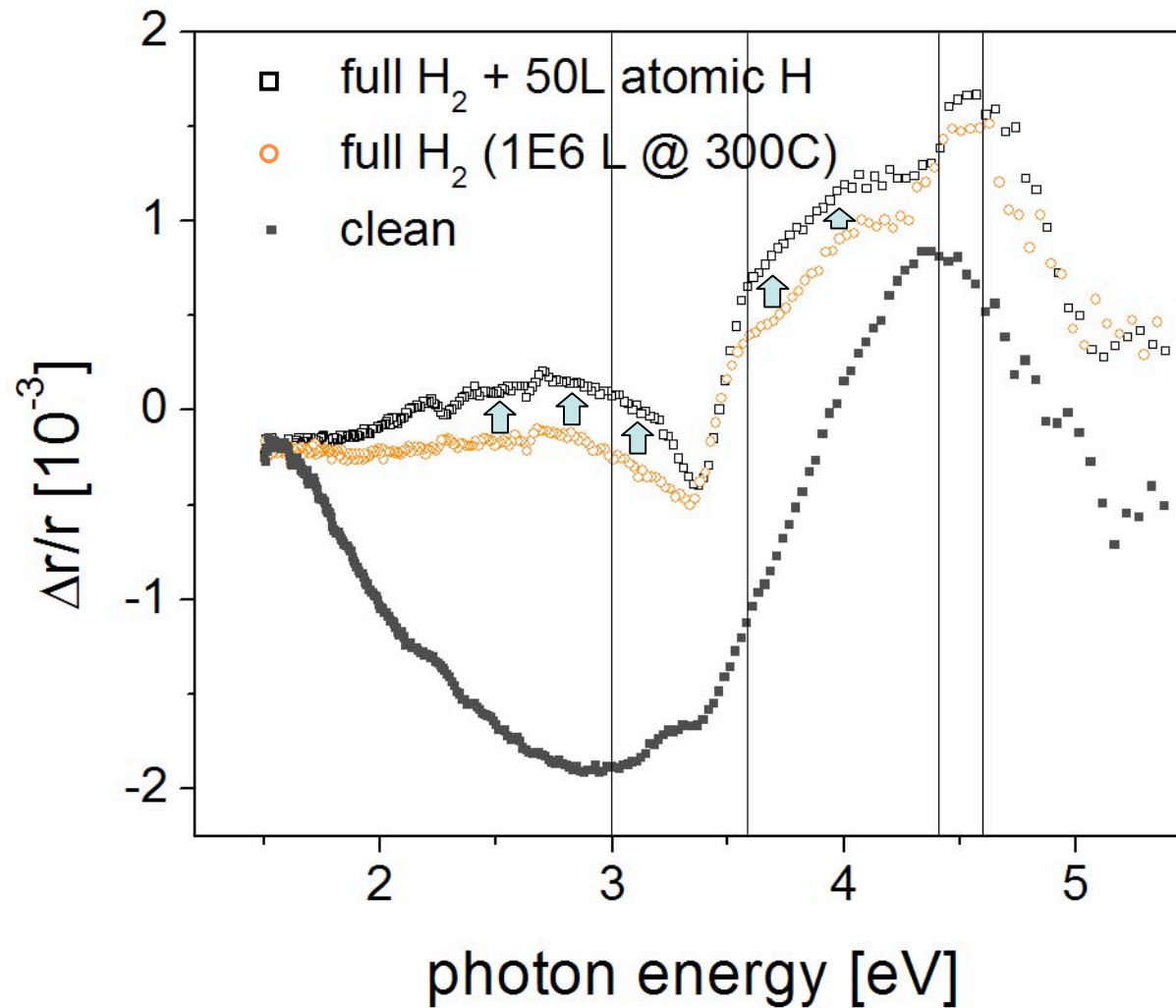
Si(001):4° 780nm 45° incidence



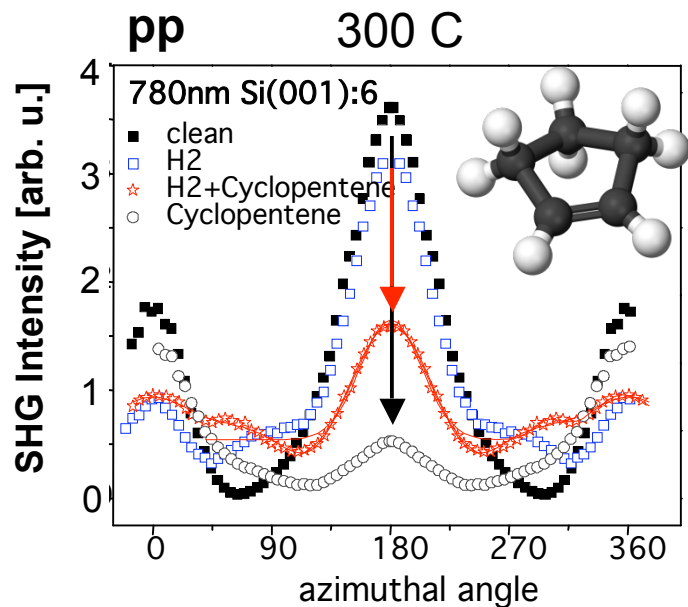
— step rebond

— step backbond

# RAS is a “spectator” as the rebond breaks



# RAS-SHG-SBHM Case Study #3: monitor and control of nanofabrication of organic monolayers on Si(001)

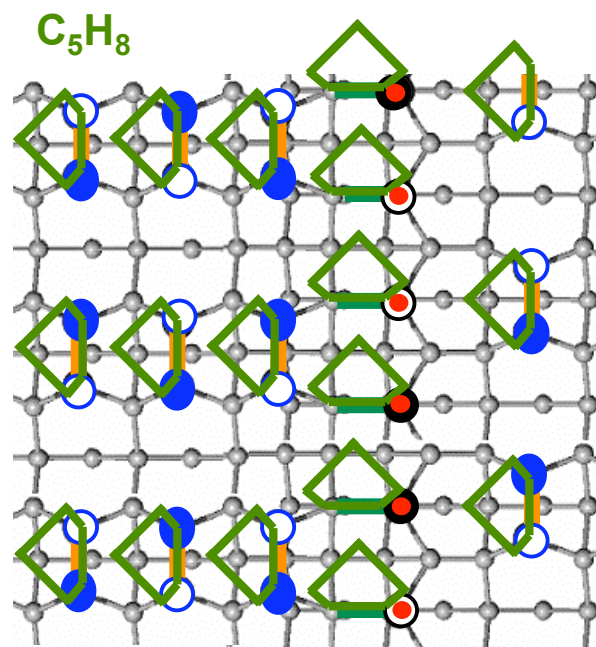
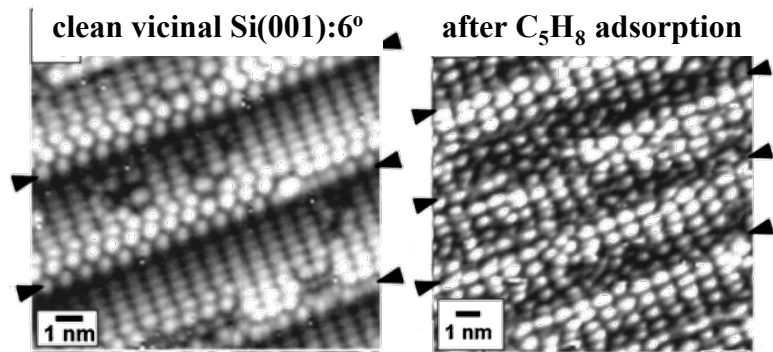
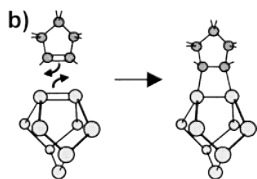


SHG, on the other hand, shows ...

... C<sub>5</sub>H<sub>8</sub> reacts immediately & strongly with step rebonds of the clean Si(001):6° surface

... H<sub>2</sub> pre-adsorption at step db's partially **protects** steps from reacting with C<sub>5</sub>H<sub>8</sub>

STM shows C<sub>5</sub>H<sub>8</sub> bonds to Si=Si terrace dimers to form an ordered monolayer.



Hamers *et al.* (2000). *Acc. Chem. Res.* **33**(9): 617-624  
 Lu *et al.*, *Phys. Rev. B* **68**, 115327 (2003)

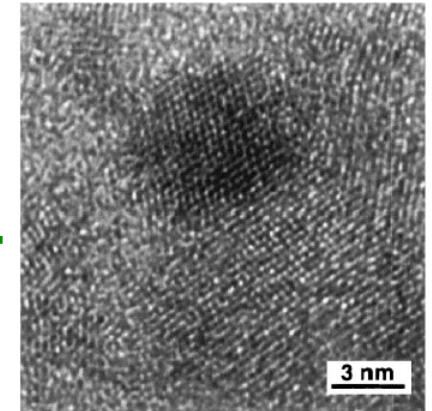


## Summary:

# Noninvasive optical spectroscopy of nano-interfaces

## I. 0-D: Si NCs embedded in SiO<sub>2</sub>

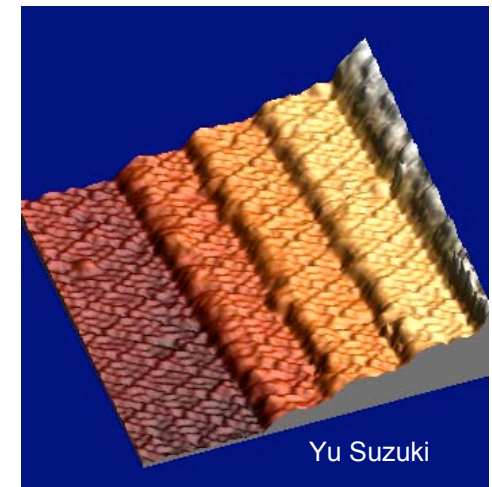
- importance: Si LEDs, bio-sensors
- method: **XP2-SHG + SE, Raman, XPS, PL**
- results: new SHG evidence for a-Si and SiO<sub>x</sub> nano-interfacial transition regions



Figliozzi *et al.*, Phys. Rev. Lett. 94, 047401 (2005); Wei *et al.*, in preparation

## II. 1-D: step-edges of vicinal Si

- importance: templates for molecular electronics, quantum wires & computers
- method: **SHG & RAS & SBHM**
- results: visualization of formation of step Si-H bond and of breaking of step rebond;
  - control & optical monitoring of cyclopentene nano-lithography by self-assembly



Kwon *et al.*, Phys. Rev. B 73, 195330 (2006).

Ehlert *et al.*, J. Opt. Soc. Am. B 27, 981 (2009) & more in the oven.

**END**